



**DeltaGT**  
**MI 3309**  
**Instruction manual**  
*Ver. 1.0, Code no. 20 751 860*


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# 1 General description

The multifunctional portable appliance tester DeltaGT is intended to perform measurements for testing the electrical safety of portable electrical equipment.

The following tests can be performed:

- › visual inspection;
- › earth continuity resistance;
- › insulation resistance;
- › insulation resistance of isolated accessible conductive parts;
- › substitute leakage current;
- › substitute leakage current of isolated accessible conductive parts;
- › IEC cord polarity test;
- › differential leakage current test;
- › touch leakage test;
- › RCD and PRCD tests;
- › power test;
- › TRMS voltage;
- › functional test.

Some instrument's highlights:

- › Power supply from both mains power and batteries;
- › graphic LCD with resolution of 128 x 64 dots, with backlight;
- › large data flash memory for storing test results and parameters (approx. 1500 tests can be stored);
- › two communication ports (USB and RS232C) for communication with PC, barcode scanner, printer and RFID reader/writer;
- › additional connectors for fixed appliances testing;
- › built-in real time clock;
- › fully compatible with new METREL PATLink PRO PC software package;

Powerful functions for fast and efficient periodic testing are included:


- › pre-programmed test sequences;
- › fast testing with the help of barcodes and RFID tags;
- › custom test sequences can be uploaded from PC.

The graphic display with backlight offers easy reading of results, indications, measurement parameters and messages. Two LED Pass/Fail indicators are placed at the sides of the LCD.

The unit is very intuitive to use and has help menus describing how to perform each test. The operator therefore does not need any special training (except reading this instruction manual) to operate the instrument.

## 1.1 Warnings

In order to reach a high level of operator safety while carrying out various measurements using the instrument, as well as to keep the test equipment undamaged, it is necessary to consider the following general warnings:

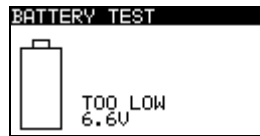
- ›  **Warning on the instrument means »Read the Instruction manual with special care to safety operation«. The symbol requires an action!**
- › **Read this instruction manual carefully, otherwise use of the instrument may be dangerous for the operator, for the instrument or for the equipment under test!**
- › **If the test equipment is used in manner not specified in this instruction manual the protection provided by the equipment may be impaired!**
- › **Do not use the instrument and accessories if any damage is noticed!**
- › **Do not touch any test leads/terminals while the appliance is connected to the MI 3309 DeltaGT.**
- › **Consider all generally known precautions in order to avoid risk of electric shock while dealing with hazardous voltages!**
- › **Use only correctly earthed mains outlets to supply the instrument!**
- › **The mains supply voltage has to be higher than 80 V a.c. otherwise the internal power supply could be damaged.**
- › **Use only standard or optional test accessories, supplied by your distributor!**
- › **Instrument servicing and adjustment have to be carried out by competent authorized personnel!**
- › **Hazardous voltages can exist inside the instrument. Disconnect all test leads, remove the power supply cable and switch off the instrument before opening the battery compartment.**
- › **Instrument contains rechargeable NiCd or NiMh battery cells. The cells should only be replaced with the same type as defined on the battery placement label or in this manual. Do not use alkaline battery cells.**
- › **If a test code with an earth continuity test current higher than 200 mA is selected (manually, with barcode scanner or with RFID reader/writer) the DeltaGT instrument will automatically perform the Earth continuity test with a 200 mA test current. Other test parameters remain unchanged. The operator must be competent to decide if performing the test with a 200 mA current is acceptable!**

## 1.2 Battery and charging

The instrument uses six AA size rechargeable NiCd or NiMH battery cells. Alkaline battery cells are not allowed.

Battery condition is always displayed in the upper right corner of the display.

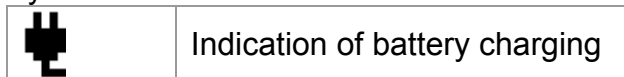
If the battery power becomes too weak, the instrument indicates this as shown in **Figure 1.1**. This indication appears for a few seconds and then the instrument turns itself off.



**Figure 1.1:** Discharged battery indication

The battery is charged whenever the instrument is connected to mains voltage. The instrument automatically recognizes the connection to the mains voltage and begins charging. Internal circuit controls charging and assures maximum battery lifetime.

Symbols:



**Figure 1.2:** Charging indication on display

- ▶ **⚠ When connected to an installation, the instruments battery compartment can contain hazardous voltage inside! Before opening the battery compartment cover, disconnect all accessories connected to the instrument and switch off the instrument.**
- ▶ Ensure that the battery cells are inserted correctly otherwise the instrument will not operate and the batteries could be discharged.
- ▶ If the instrument is not to be used for a long period of time, remove all batteries from the battery compartment.
- ▶ Rechargeable NiCd or NiMH batteries type HR 6 (size AA) can be used. Metrel recommends only using rechargeable batteries with a capacity of 2100mAh or higher.

### 1.3 New battery cells or cells unused for a longer period

Unpredictable chemical processes can occur during the charging of new battery cells or cells that have been left unused for a longer period (more than 3 months). NiMH and NiCd cells can be subjected to these chemical effects (sometimes called the memory effect). As a result the instrument operation time can be significantly reduced during the initial charging/discharging cycles of the batteries.

In this situation, Metrel recommend the following procedure to improve the battery lifetime:

Procedure	Notes
<ul style="list-style-type: none"> <li>‣ Completely charge the battery.</li> </ul>	At least 14h with the in-built charger.
<ul style="list-style-type: none"> <li>‣ Completely discharge the battery.</li> </ul>	This can be performed by using the instrument normally until the instrument is fully discharged.
<ul style="list-style-type: none"> <li>‣ Repeat the charge / discharge cycle at least 2-4 times.</li> </ul>	Four cycles are recommended in order to restore the batteries to their normal capacity.

**Note:**

- The charger in the instrument is a pack cell charger. This means that the battery cells are connected in series during the charging. The battery cells have to be equivalent (same charge condition, same type and age).
- One different battery cell can cause an improper charging and incorrect discharging during normal usage of the entire battery pack (it results in heating of the battery pack, significantly decreased operation time, reversed polarity of defective cell,...).
- If no improvement is achieved after several charge / discharge cycles, then each battery cell should be checked (by comparing battery voltages, testing them in a cell charger, etc). It is very likely that only some of the battery cells are deteriorated.
- The effects described above should not be confused with the normal decrease of battery capacity over time. Battery also loses some capacity when it is repeatedly charged / discharged. Actual decreasing of capacity, versus number of charging cycles, depends on battery type. This information is provided in the technical specification from battery manufacturer.

## 1.4 Standards applied

The DeltaGT is manufactured and tested in accordance with the following regulations:

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### *Electromagnetic compatibility (EMC)*

EN 61326	Electrical equipment for measurement, control and laboratory use – EMC requirements Class B (Hand-held equipment used in controlled EM environments)
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### *Safety (LVD)*

EN 61010-1	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 1: General requirements
EN 61010-031	Safety requirements for hand-held probe assemblies for electrical measurement and test

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### *Functionality*

EN 61557	Electrical safety in low voltage distribution systems up to 1000 V <sub>AC</sub> and 1500 V <sub>AC</sub> – Equipment for testing, measuring or monitoring of protective measures Part 2 Insulation resistance Part 4 Resistance of earth connection and equipotential bonding
VDE 0404-1	Testing and measuring equipment for checking the electric safety of electric devices - Part 1: General requirements
VDE 0404-2	Testing and measuring equipment for checking the electric safety of electric devices - Part 2: Testing equipment for tests after repair, change or in the case of repeat tests

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### *Other reference standards for testing portable appliances*

VDE 0701-702	Inspection after repair, modification of electrical appliances – Periodic inspection on electrical appliances General requirements for electrical safety
NEN 3140	Guidelines for safe working practices The IEE Code of Practice for In-service Inspection and Testing of Electrical Equipment 3 <sup>rd</sup> edition

### **Note about EN and IEC standards:**

- Text of this manual contains references to European standards. All standards of EN 6XXXX (e.g. EN 61010) series are equivalent to IEC standards with the same number (e.g. IEC 61010) and differ only in amended parts required by European harmonization procedure.

## 2 Instrument description

### 2.1 Front panel



**Figure 2.1:** Front panel

*Legend:*

1	LCD	128 x 64 dots matrix display with backlight.
2	FAIL	Red indicator
3	PASS	Green indicator
4	TEST	Starts testing / confirms selected option.
5	UP	Selects parameter / changes value of selected parameter.
6	DOWN	
7	MEM	Store / recall / clear tests in memory of instrument.
8	TAB	Selects the parameters / item / option in selected function.
9	ON / OFF	Switches the instrument power on or off.
	ESC	To switch the instrument Off the key must be pressed for 2 seconds. The instrument automatically turns off in 15 minutes after the last key was pressed.
		Returns to previous level.
10		Test socket.

## 2.2 Connector panel

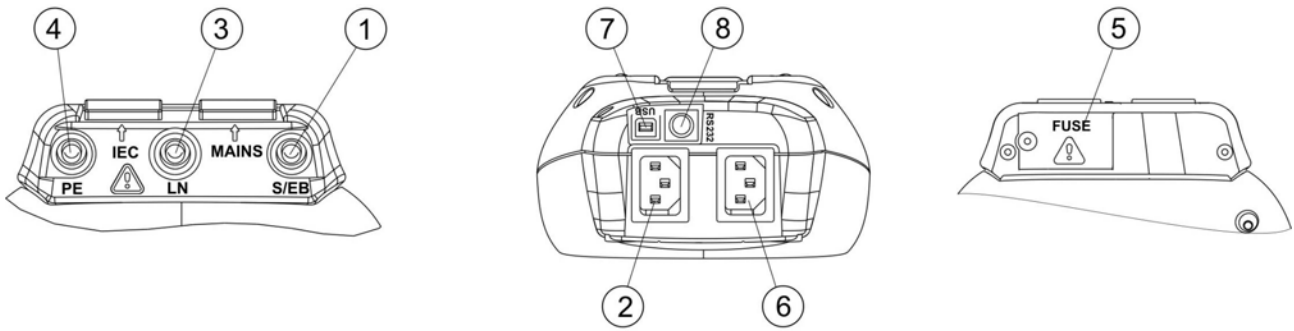


Figure 2.2: Connector panel

*Legend:*

1 S/EB	Probe and Earth continuity terminal
2 IEC	IEC test terminal
3 LN	LN terminal (for connection of fixed installed appliances)
4 PE	PE terminal (for connection of fixed installed appliances)
5 FUSE compartment	Fuses: 2 x T16 A / 250 V; breaking capacity: 1500 A (for protection against overload and short circuit)
6 MAINS	Mains supply connector and test terminal. (Used for charging, Voltage and (P)RCD tests also)
7 USB connector	Communication with PC USB (1.1) port.
8 PS/2 connector	Communication with barcode scanner. Communication with printer. Communication with RFID reader/writer. Communication with PC RS232 port.

**Warning:**

- ▶ **Maximum allowed voltage on MAINS terminal is 300 V (CAT II)!**

## 2.3 Back side



Figure 2.3: Back side

*Legend:*

- 
- |   |  |
|---|--|
| 1 | Inserts for side belt                          |
| 2 | Battery compartment cover                      |
| 3 | Fixing screw for battery compartment cover     |
| 4 | Back side information label                    |
| 5 | Holder for inclined position of the instrument |
- 



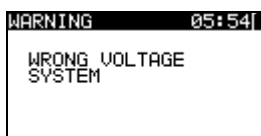
**Figure 2.4:** Battery compartment

*Legend:*

- 
- |   |                     |   |
|---|---------------------|---|
| 1 | Battery cells       | Type HR 6 (size AA), rechargeable NiMH / NiCd |
| 2 | Serial number label |   |
-

## 2.4 Meaning of symbols and messages on the instrument display

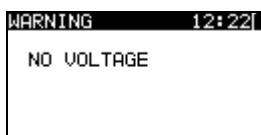
Before performing a measurement, the instrument performs a series of pre-tests to ensure safety and to prevent any damage. These safety pre-tests are checking for any external voltage and load condition on test terminals. If a pre-test fails, an appropriate warning message will be displayed. Warnings and protective measures are described in this chapter.



### WARNING!

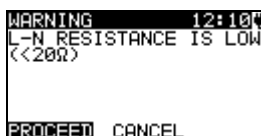
Improper supply voltage warning. Possible causes:

- no earth connection or other wiring problem on supply socket,
- instrument is connected to 110 V or IT earthing supply system.



### WARNING!

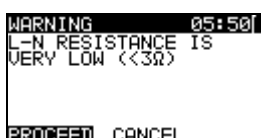
No voltage was detected on the mains input. Check mains connection.



### WARNING!

A low resistance of the appliance' supply input was measured in the pre-test. This means that most likely a high current will flow after applying power to the tested appliance. If the high current is only of short duration (caused by a short inrush current) the test can be performed, otherwise not.

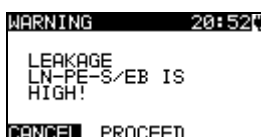
Select **PROCEED** or **CANCEL**.



### WARNING!

A very low resistance of the appliance' supply input was measured in the pre-test. It is likely that fuses will blow after applying power to the tested appliance. If the too high current is only of short duration (caused by an inrush current) the test can be performed otherwise it must be stopped.

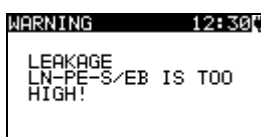
Select **PROCEED** or **CANCEL**. It is recommended to additionally check the appliance before proceeding with the test!



### WARNING!

A high leakage current (higher than 3.5 mA) will flow if power would be connected to the tested appliance.

Select **PROCEED** or **CANCEL**. Proceed with testing only if all safety measures have been taken.



### WARNING!

A dangerous leakage current (higher than 20 mA) will flow if power would be connected to the tested appliance. The instrument blocks the test.

```

WARNING 16:57
L-N RESISTANCE IS TOO
HIGH (>30kΩ). CHECK
FUSE AND ON/OFF
SWITCH.
PROCEED CANCEL

```

**WARNING!**

A high resistance between L and N was measured in the fuse pre-test. This indication means that the device under test has very low power consumption or it is:

- › not connected;
- › switched off;
- › contains a fuse that has blown.

Select **PROCEED** or **CANCEL**.

```

WARNING 17:00
External voltage
on test socket
too high!

```

**WARNING!**

Voltage on test socket or IEC test terminal is higher than approximately 20 V (AC or DC)!

Disconnect the device under test from the instrument immediately and determine why an external voltage was detected!

```

WARNING 12:01
OUT OF CUSTOM
AUTOTEST MEMORY

```

**WARNING!**

The custom autotest memory has reached the limit of 50 sequences.

```

WARNING 12:04
OUT OF MEMORY

```

**WARNING!**

The internal memory is full!

```

WARNING 14:27
CALIBRATION
PERIOD WILL
EXPIRE IN 29
DAYS.

```

**WARNING!**

The calibration period will expire in less than 1 month. The instrument counts down the days.

```

WARNING 14:15
CALIBRATION
PERIOD HAS
EXPIRED.

```

**WARNING!**

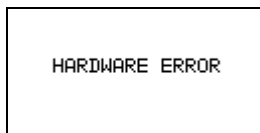
The calibration period has expired. Recalibrate the instrument!

```

WARNING 12:10
PE NOT CONNECTED

```

PE between test socket and IEC test terminal is not connected!



The instrument detects a serious failure. Switch OFF the instrument. Disconnect all cables and leads. Switch ON the instrument again. **Return the instrument to the repair centre if the message is displayed again.**



**WARNING!**

A high voltage will be present on the output of the instrument!



**WARNING!**

A high insulation test voltage is present on the output of the instrument.



Measurement is in progress.



Test result can be saved.



Connect the test lead to the S/EB test terminal.



Flex the mains cable of appliance during the test.



Check that the device under test is switched on (to ensure that the complete circuit is tested).



Connect the cord to be tested to the IEC test terminal.



Test passed.



Test failed.



Measurement was aborted due to improper conditions during the test.



RCD must be switched on.



Change position of mains cord before RCD test.



Indicate which connection in the test socket is over the limit. (blank contact - under limit, filled contact - over limit)

### 2.4.1 Battery indication

The indication shows the charge condition of battery and connection of external charger.



Battery capacity indication.



Low battery.  
Battery is too weak to guarantee correct result.  
Replace or recharge the battery cells.



Instrument is connected to the mains (and is charging)

## 3 Technical specifications

### 3.1 Earth continuity

Range	Resolution	Accuracy
0.00 $\Omega$ ÷ 19.99 $\Omega$	0.01 $\Omega$	$\pm(5\%$ of reading + 3 digits)
20.0 $\Omega$ ÷ 199.9 $\Omega$	0.1 $\Omega$	Indication only
200 $\Omega$ ÷ 1999 $\Omega$	1 $\Omega$	

Powered by..... battery or mains  
 Test currents..... 200 mA into 2.00  $\Omega$   
 Open circuit voltage ..... <9 V AC  
 Pass levels..... 0.10  $\Omega$ , 0.20  $\Omega$ , 0.30  $\Omega$ , 0.40  $\Omega$ , 0.50  $\Omega$ , 0.60  $\Omega$ , 0.70  $\Omega$ ,  
 0.80  $\Omega$ , 0.90  $\Omega$ , 1.00  $\Omega$ , 1.50  $\Omega$ , 2.00  $\Omega$   
 Test duration..... 2 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s  
 Test method..... 2-wire measurement  
 Test terminals ..... PE (Test socket)  $\leftrightarrow$  S/EB (probe)  
 PE (IEC Cord)  $\leftrightarrow$  PE (Test socket)  
 PE (terminal)  $\leftrightarrow$  S/EB (probe) (for fixed installed  
 appliances)

### 3.2 Insulation resistance, Insulation – P resistance

Range	Resolution	Accuracy
0.00 M $\Omega$ ÷ 19.99 M $\Omega$	0.01 M $\Omega$	$\pm(5\%$ of reading + 3 digits)
20.0 M $\Omega$ ÷ 49.9 M $\Omega$	0.1 M $\Omega$	
50.0 M $\Omega$ ÷ 199.9 M $\Omega$	0.1 M $\Omega$	Indication only

Powered by..... battery or mains  
 Nominal voltages ..... 250 V DC, 500 V DC (- 0 %, + 10 %)  
 Measuring current..... min. 1 mA at 250 k $\Omega$  (250 V), 500 k $\Omega$  (500 V)  
 Short circuit current..... max. 2.0 mA  
 Pass levels..... 0.01 M $\Omega$ , 0.10 M $\Omega$ , 0.25 M $\Omega$ , 0.30 M $\Omega$ , 0.50 M $\Omega$ , 1 M $\Omega$ , 2  
 M $\Omega$ , 4 M $\Omega$ , 7 M $\Omega$ , 10 M $\Omega$ , --- M $\Omega$   
 Test duration..... 2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s  
 Test terminals (Insulation)..... LN (Test socket)  $\leftrightarrow$  PE (Test socket)  
 LN (terminal)  $\leftrightarrow$  PE (terminal) (for fixed installed  
 appliances)  
 LN (Test socket)  $\leftrightarrow$  S/EB (probe)  
 LN (terminal)  $\leftrightarrow$  S/EB (probe) (for fixed installed  
 appliances)  
 Test terminals (Insulation-P)..... LN (Test socket)  $\leftrightarrow$  S/EB (probe)  
 LN (terminal)  $\leftrightarrow$  S/EB (probe) (for fixed installed  
 appliances)

### 3.3 Substitute leakage current, Substitute leakage – P current

Range	Resolution	Accuracy
0.00 mA ÷ 9.99 mA	0.01 mA	±(5 % of reading + 3 digits)
10.0 mA ÷ 20.0 mA	0.1 mA	

Powered by..... battery or mains

Open circuit voltage ..... <50 V AC at rated mains voltage

Short circuit current..... <40 mA

Pass levels:

Substitute leakage ..... 0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA, 5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, ---- mA

Substitute leakage - P ..... 0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, --- mA

Test duration..... 2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s

Displayed current..... calculated to appliance nominal mains supply voltage (230 V)

Test terminals (Sub. leakage) ... LN (Test socket) ↔ PE (Test socket)

LN (terminal) ↔ PE (terminal) (for fixed installed appliances)

LN (Test socket) ↔ S/EB (probe)

LN (terminal) ↔ S/EB (probe) (for fixed installed appliances)

Test terminals (Sub. leakage-P) LN (Test socket) ↔ S/EB (probe)

LN (terminal) ↔ S/EB (probe) (for fixed installed appliances)

### 3.4 Polarity test

Powered by..... battery or mains

Test voltage ..... <50 V AC

Detects..... PASS, L OPEN, N OPEN, PE OPEN, L-N CROSS, L-N SHORT, L-PE SHORT, N-PE SHORT, MULTIPLE FAULT.

Test terminals ..... Test socket ↔ IEC test terminal

### 3.5 Differential leakage current

Range	Resolution	Accuracy
0.00 mA ÷ 19.99 mA	0.01 mA	±(5 % of reading + 5 digits)

Apparent power Indication only

Powered by..... mains

Pass levels:..... 0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA, 5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.00 mA, 15.00 mA, ---- mA

Test duration:..... 2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s

Frequency response: ..... complies with EN61010-1 Figure A1

Test terminals ..... Test socket

Additional error ..... 0,01 mA/A

\* Measurement is limited to 120 s if ( $I_{load} > 10$  A).

### 3.6 Touch leakage current

Range	Resolution	Accuracy
0.00 mA ÷ 7.00 mA	0.01 mA	±(10 % of reading + 5 digits)

Apparent power Indication only

Powered by.....mains

Pass levels:.....0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA 2.25 mA, 2.50 mA, 3.50 mA, --- mA

Test duration:.....2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s

Frequency response .....complies with EN61010-1 Figure A1

Test terminals .....Test socket – EB/S test probe

\* Measurement is limited to 120 s if ( $I_{load} > 10$  A).

### 3.7 PRCD and RCD testing

#### 3.7.1 General RCD Trip-out time

Complete measurement range corresponds to EN 61557-6 requirements.

Maximum measuring times set according to selected reference for RCD testing.

Range	Resolution	Accuracy
0 ms ÷ 300 ms ( $\frac{1}{2} \times I_{\Delta N}$ )	0.1 ms	±3 ms
0 ms ÷ 300 ms ( $I_{\Delta N}$ )	0.1 ms	
0 ms ÷ 40 ms ( $5 \times I_{\Delta N}$ )	0.1 ms	±1 ms

Powered by..... mains  
 Test current.....  $\frac{1}{2} \times I_{\Delta N}$ ,  $I_{\Delta N}$ ,  $5 \times I_{\Delta N}$  ( $I_{\Delta N} = 10 \text{ mA}, 15 \text{ mA}, 30 \text{ mA}$ )  
 Start angle .....  $0^\circ, 180^\circ$ , both  
 Test modes ..... single, autotest

Test terminals MAINS terminal

Specified accuracy is valid for complete operating range.

### 3.7.2 Portable RCD trip-out time

Range	Resolution	Accuracy
0 ms ÷ 300 ms ( $\frac{1}{2} \times I_{\Delta N}$ )	0.1 ms	±3 ms
0 ms ÷ 300 ms ( $I_{\Delta N}$ )	0.1 ms	
0 ms ÷ 40 ms ( $5 \times I_{\Delta N}$ )	0.1 ms	±1 ms

Powered by..... mains  
 Test current.....  $\frac{1}{2} \times I_{\Delta N}$ ,  $I_{\Delta N}$ ,  $5 \times I_{\Delta N}$  ( $I_{\Delta N} = 10 \text{ mA}, 15 \text{ mA}, 30 \text{ mA}$ )  
 Start angle .....  $0^\circ, 180^\circ$ , both  
 Test modes ..... single, autotest

Test terminals Test socket – IEC test terminal

Specified accuracy is valid for complete operating range.

## 3.8 Power

### Apparent power

Range	Resolution	Accuracy
0.00 kVA ÷ 4.00 kVA	0.01 kVA	±(5 % of reading + 3 digits)

Powered by..... mains  
 Test duration:..... 2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s  
 Test terminals ..... MAINS terminal  
 \* Measurement is limited to 120 s if ( $I_{load} > 10 \text{ A}$ ).

## 3.9 TRMS Voltage

Range	Resolution	Accuracy
80 ÷ 300 V	1 V	±(2 % of reading + 2 digits)

Frequency Indication only.

Result type ..... True r.m.s.  
 Nominal frequency range ..... 0 Hz, 50 Hz ÷ 60 Hz  
 Frequency accuracy ..... Indication only

Test terminals ..... MAINS terminal

### 3.10 General data

Power supply voltage..... 9 V<sub>DC</sub> (6×1.2 V NiMH or NiCd battery, type HR 6)  
(size AA)

Operation ..... typical 8 h

Battery charging current..... 250 mA (internally regulated)

Oversvoltage category..... CAT II / 300 V

Protection classification ..... double insulation

Pollution degree ..... 2

Protection degree case ..... IP 40

Protection degree test connectors .... IP 20

Display ..... 128 x 64 dots matrix display with backlight

Dimensions (w × h × d) ..... 14 cm × 8 cm × 26 cm

Weight ..... 1.14 kg, without battery cells

Reference conditions:

Reference temperature range..... 10 °C ÷ 30 °C

Reference humidity range..... 40 %RH ÷ 70 %RH

Operation conditions:

Working temperature range ..... 0 °C ÷ 40 °C

Maximum relative humidity ..... 95 %RH (0 °C ÷ 40 °C), non-condensing

Storage conditions:

Temperature range ..... -10 °C ÷ +70 °C

Maximum relative humidity ..... 90 %RH (-10 °C ÷ +40 °C)

80 %RH (40 °C ÷ 60 °C)

The error in operating conditions could be at most the error for reference conditions (specified in the manual for each function) +1 % of measured value + 1 digit, unless otherwise specified in the manual for particular function.

Memory.....1500 memory locations

Communication transfer speed:

RS232 interface ..... 9600 bps, 19200 bps, 38400 bps, 57600 bps,  
115200 bps, 1 start bit, 8 data bits, 1 stop bit

RS232 connector ..... PS/2 connector, female

USB interface..... 115200 bps, 256000 bps

USB connector..... type B

Protection pre-tests:

- External voltage between LN and PE (DC and AC).
- Excessive leakage between S/EB and PE (DC and AC).
- L-N resistance is low or very low.

Connectivity (fuse) pre-test:

- Appliance is not switched on or there is too high resistance between L and N.

Maximum resistance for connectivity pre-test ..... 30 kΩ

## 4 Main menu and test modes

### 4.1 Instrument Main menu

From the Main menu of the instrument there are five instrument operation modes, Help menu and Setup menu can be selected:



Figure 4.1: Instrument Main menu

Keys:

<p>▲ / ▼ TAB</p>	<p>Select one of the following menu items:</p> <p>&lt;<b>VDE ORGANIZER</b>&gt; pre-programmed test sequences according to the VDE 0701-0702 norm, see <i>chapter 6.1 VDE organizer setup menu</i> ;</p> <p>&lt;<b>SINGLE TEST</b>&gt; individual tests, see <i>chapter 5 Single test</i>;</p> <p>&lt;<b>CUSTOM AUTOTEST</b>&gt; user defined pre-programmed sequences, see <i>chapter 6.2 Custom autotest</i> ;</p> <p>&lt;<b>SIMPLE TEST</b>&gt; simple pre-programmed sequences, see <i>chapter 6.3 Simple test</i></p> <p>&lt;<b>CODE AUTOTEST</b>&gt; code-based test sequences, suitable for working with barcodes and RFID tags, see <i>chapter 6.4 Code Autotest</i>;</p> <p>&lt;<b>HELP</b>&gt; help screens;</p> <p>&lt;<b>SETUP</b>&gt; menu for setup of the instrument, see <i>chapter 4.7 Setup menu</i>;</p>
<p>TEST</p>	<p>Confirms selection.</p>

### 4.2 VDE Organizer menu

This menu offers creation and performing of VDE compatible test sequences. The sequence setup and its parameters are the same as suggested in the VDE 0701-0702 standard. After an autotest sequence has been created in the VDE organizer, it can be run as an autotest or stored in the Custom Autotest menu.

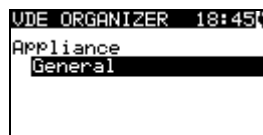
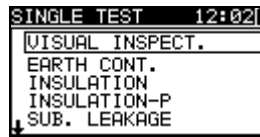


Figure 4.2: VDE organizer menu

See *chapter 6.1 VDE organizer setup menu* for more information.

### 4.3 Single test menu

In single test menu individual tests can be performed.

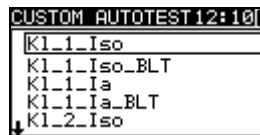


**Figure 4.3:** Single test menu

See chapter 5 *Single test* for more information.

### 4.4 Custom Autotest menu

This menu contains a list of custom prepared autosequences. The commonly used autotest sequences are added to the list by default. Up to 50 custom autotest sequences can be pre-programmed in this autotest mode. Custom autotest can also be uploaded from the PC SW PATLink PRO Plus.

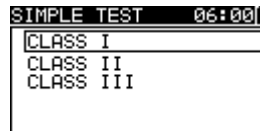


**Figure 4.4:** Custom Autotest menu

See chapter 6.2 *Custom autotest* for detailed description of this test mode.

### 4.5 Simple test menu

This menu contains a list of simple test sequences.



**Figure 4.5:** Simple test menu

See chapter 6.3 *Simple test* for detailed description about this test mode.

### 4.6 Code Autotests menu

Code Autotests menu supports operation with predefined test codes, barcodes and RFID tags. Test codes can be selected with the barcode scanner or with the ▲ / ▼ keys.



**Figure 4.6:** Code Autotest menu

See chapter 6.4 *Code Autotest* for more information.

## 4.7 Help menu

Help menu contains schematic diagrams to illustrate how to correctly connect a device under test to the PAT testing instrument.



Figure 4.7: Example of help screens

Keys:

▲/▼	Selects next / previous help screen.
<b>TEST</b> , <b>ESC</b>	Returns to <b>Main menu</b> .

## 4.8 Setup menu

In the Setup menu different parameters and settings of the instrument can be viewed or set.



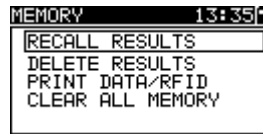
Figure 4.8: Setup menu

Keys:

▲ / ▼	Select the setting to adjust or view: < <b>MEMORY</b> > to recall, print or clear stored results, print labels and write RFID tags; < <b>LANGUAGE</b> > instrument language; < <b>LCD</b> > LCD contrast and backlight settings; < <b>TEST SPEED SETUP</b> > to select the speed of the test; < <b>DATE/TIME</b> > date and time; < <b>USER DATA</b> > user data settings (initials); < <b>INSTRUMENT DATA</b> > basic instrument information; < <b>INIT. SETTINGS</b> > factory settings; < <b>COMMUNICATION</b> > communication settings.
<b>TEST</b>	Confirms selection.
<b>ESC</b>	Returns to the <b>Main menu</b> .

### 4.8.1 Memory

In the Memory menu stored results can be recalled, printed or deleted. Labels can be printed and RFID tags can be written in this menu.



**Figure 4.9: Memory menu**

See chapter 7 *Working with autotest results* for more information.

## 4.8.2 Language selection

The instrument language can be set in this menu.



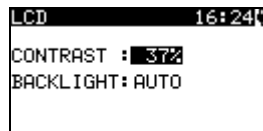
**Figure 4.10: Language menu**

Keys:

▲ / ▼	Selects the language.
<b>TEST</b>	Confirms selection and returns to <b>Setup menu</b> .
<b>ESC</b>	Returns to <b>Setup menu</b> without changes.

## 4.8.3 LCD contrast and backlight

In this menu the contrast and backlight mode of the LCD can be set.



**Figure 4.11: LCD contrast menu**

*Backlight modes:*

AUTO	The high backlight level is active for 30 seconds after last pressing of any key. Then the backlight level returns to low level until a key is pressed again.
OFF	Backlight level is low.
ON	Backlight level is high.

Keys:

<b>TAB</b>	Toggles between setup of contrast and backlight
▲ / ▼	Sets contrast value or backlight mode
<b>TEST</b>	Confirms selection and returns to <b>Setup menu</b> .
<b>ESC</b>	Returns to <b>Setup menu</b> without changes.

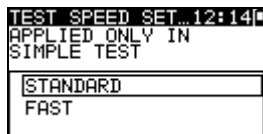
**Note:**

- If you press the down (▼) key while starting up the instrument you will automatically jump to the LCD contrast menu.

- While the instrument is connected to mains voltage the backlight is automatically switched to the HIGH level.

#### 4.8.4 Test speed setup

In this menu the instrument test speed can be set:



**Figure 4.12:** Test speed menu

Options:

- STANDARD** Default option.  
**FAST** No pauses during tests (default).

Keys:

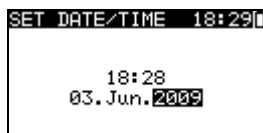
▲ / ▼	Selects the speed mode.
<b>TEST</b>	Confirms selection and returns to <b>Setup menu</b> .
<b>ESC</b>	Returns to <b>Setup menu</b> without changes.

**Note:**

- When enabling the fast mode then Visual inspection and Functional Test will be automatically set to PASS.

#### 4.8.5 Setting date and time

Date and time can be set in this menu.



**Figure 4.13:** Date and time menu

Keys:

<b>TAB</b>	Selects the field to be changed.
▲ / ▼	Modifies selected field.
<b>TEST</b>	Confirms selection and returns to <b>Setup menu</b> .
<b>ESC</b>	Returns to <b>Setup menu</b> without changes.

**Note:**

- Date is attached to each stored autotest result.

**Warning:**

- If the batteries are removed for more than 1 minute the set time and date will be lost.

### 4.8.6 User data

User data can be set in this menu.

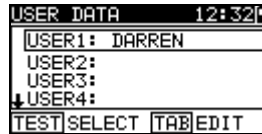


Figure 4.14: User data menu

Keys:

▲ / ▼	Selects the user name.
TEST	Confirms selection and returns to <b>Setup menu</b> .
ESC	Returns to <b>Setup menu</b> without changes.
TAB	Enters <b>Edit user data menu</b> .

Edit user data:



Figure 4.15: Edit user data menu

Keys:

▲ / ▼	Selects a letter.
TEST	Selects the next letter.
MEM	Confirms name and returns to <b>User data menu</b> .
ESC	Deletes last letter. Returns to <b>User data menu</b> without changes.

#### Notes:

- › The selected user will be printed on the simple label (initials).
- › Five different user names can be set.

### 4.8.7 Instrument data

In this menu the following instrument data is shown:

- › producer name;
- › instrument type;
- › model number;
- › calibration date;
- › serial number;
- › firmware and hardware version.



Figure 4.16: Instrument data menu

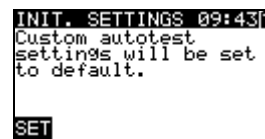
Keys:

▲ / ▼	Switches between Instrument data screens.
TEST, ESC	Returns to <b>Setup menu</b> .

### 4.8.8 Initial settings

In this menu the following instrument parameters can be set to their initial values:

- ▶ all measurement parameters in single test mode;
- ▶ LCD settings;
- ▶ language;
- ▶ communication settings;
- ▶ custom autotest sequences are replaced by factory pre-programmed ones.



**Figure 4.17:** Initial settings menu

Keys:

TEST	Confirms selection and returns to <b>Main menu</b> .
ESC	Returns to <b>Setup menu</b> without changes.

### 4.8.9 Communication port

In this menu the communication parameters can be set.

- ▶ setting the USB or RS232 port for communication with PC.
- ▶ setting the baud rate.



**Figure 4.18:** Communication menu

Keys:

TAB	Switches between options.
▲ / ▼	Selects the active communication port / Selects baud rate.
TEST	Confirms selection and returns to <b>Setup menu</b> .
ESC	Returns to <b>Setup menu</b> without changes.

**Note:**

RS232 communication port and 9600 bps baud rate should be selected for communication with barcode reader, RFID reader/writer or printer.

## 5 Single test

In a Single test mode individual tests can be performed. This is especially helpful for troubleshooting.

### 5.1 Performing measurements in single test mode

Select appropriate test in Single test menu.

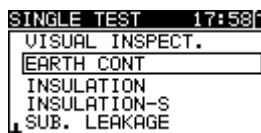


Figure 5.1: Single test menu

Keys:

▲ / ▼	Selects a single test.
TEST	Enters <b>Single test measuring menu</b> .
ESC	Returns to <b>Main menu</b> .

A single test can be started from any Single test measuring menu. Before carrying out a test the parameters / limits can be edited.



Figure 5.2: Example of single test measuring menu

Keys:

TAB	Selects a parameter.
▲ / ▼	Changes a parameter / limit.
TEST	Starts a single test.
ESC	Returns to <b>Single test menu</b> .

**Note:**

- Last set parameters will be stored automatically.

Single measurements are stored the same way as autotest results. See chapter 7.1 *Saving autotest results* for more information.

## 5.2 Measurements and inspections

### 5.2.1 Visual inspection

A thorough visual check must be carried out before each electrical safety test.

The following items should be checked:

- Inspection of the device under test for sign of damage.
- Inspection of the flexible power supply cable for damage.

- › Any signs of pollution, moisture, dirt that can jeopardize safety. Especially openings, air filters, protection covers and barriers must be checked!
- › Are there signs of corrosion?
- › Are there signs of overheating?
- › Inscriptions and markings related to safety must be clearly readable.
- › Installation of the device under test must be performed according to the instruction manual.
- › During visual inspection the measuring points for the electrical testing have to be determined too.

**Visual inspection procedure**

- › Select the VISUAL INSPECT. function.
- › Check the device under test.
- › Select PASS or FAIL according to the result of visual inspection.
- › Store the result by pressing MEM key (optional).



*Figure 5.3: Visual inspection menu*

**5.2.2 Earth continuity resistance**

This test ensures that the connections between the protective conductor terminal in the mains plug of the device under test and earthed accessible conductive parts of the device under test are satisfactory and of sufficiently low resistance. This test has to be performed on Class I (earthed) appliances. The instrument measures the resistance between:

- › S/EB terminal and PE of the test socket;
- › PE of the IEC test terminal and PE of the test socket (for IEC Cords);
- › S/EB terminal and PE terminal (for fixed installed appliances).



*Figure 5.4: Earth continuity menu*

**Test parameters for Earth continuity resistance measurement**

LIMIT	<b>Maximum resistance</b> [0.10 Ω, 0.20 Ω, 0.30 Ω, 0.40 Ω, 0.50 Ω, 0.60 Ω, 0.70 Ω, 0.80 Ω, 0.90 Ω, 1.00 Ω, 1.50 Ω, 2.00 Ω]
TIME	<b>Measuring time</b> [2 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

Typical test circuits for Earth continuity resistance measurement

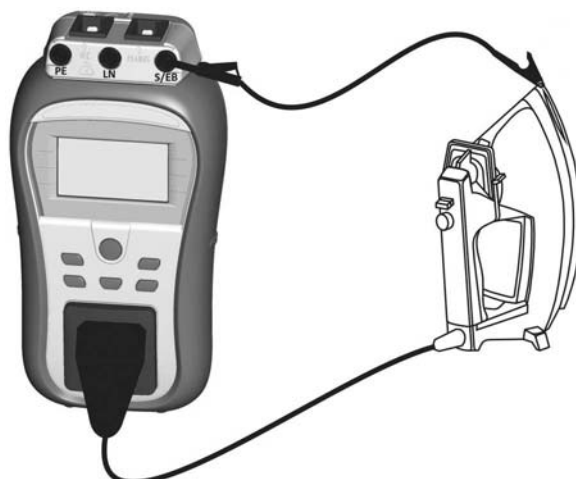


Figure 5.5: Measurement of Earth continuity

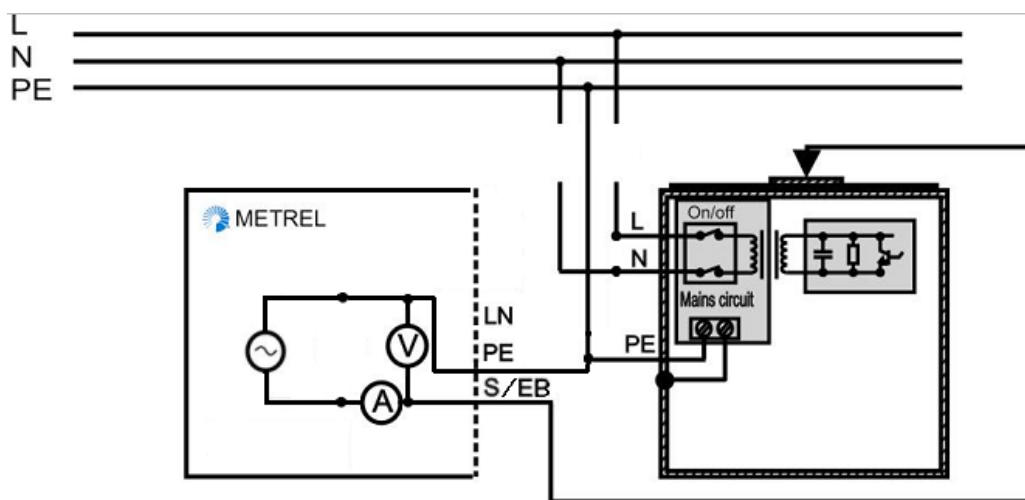


Figure 5.6: Measurement of Earth continuity of fixed installed DUTs of Class I

Earth continuity resistance measurement procedure

- ▶ Select the EARTH CONT. function.
- ▶ Set the test parameters.
- ▶ Connect device under test to the instrument (see figures 5.5 and 5.6).
- ▶ Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- ▶ Store the result by pressing MEM key (optional).

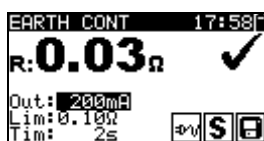


Figure 5.7: Examples of Earth continuity resistance measurement results

Displayed results:

Main result ..... Earth continuity resistance

**Note:**

- › Consider displayed warnings before starting measurement!

**5.2.3 Insulation resistance**

The insulation resistance test checks the resistance between live conductors and earthed (or isolated) accessible metal parts of a device under test. This test can disclose faults caused by pollution, moisture, deterioration of the insulation material etc.

The instrument measures the insulation resistance between:

- › The (L+N) on test socket and PE terminal on test socket / (S/EB) terminal;
- › LN terminal and PE terminal / (S/EB) terminal (for fixed installed appliances).

This function is primarily intended for testing Class I appliances.

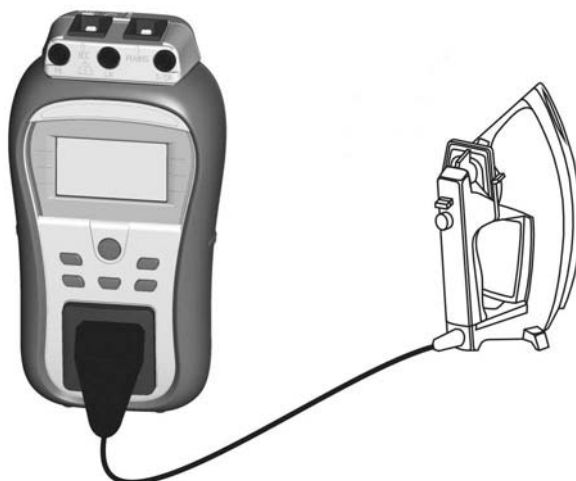


*Figure 5.8: Insulation menu*

**Test parameters for insulation resistance measurement**

OUTPUT	<b>Test voltage</b> [250 V, 500 V]
LIMIT	<b>Minimum resistance</b> [0.01 MΩ, 0.10 MΩ, 0.25 MΩ, 0.30 MΩ, 0.50 MΩ, 1 MΩ, 2 MΩ, 4 MΩ, 7 MΩ, 10 MΩ, --- MΩ]
TIME	<b>Measuring time</b> [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

**Test circuits for Insulation resistance measurement**



*Figure 5.9: Measurement of insulation resistance*

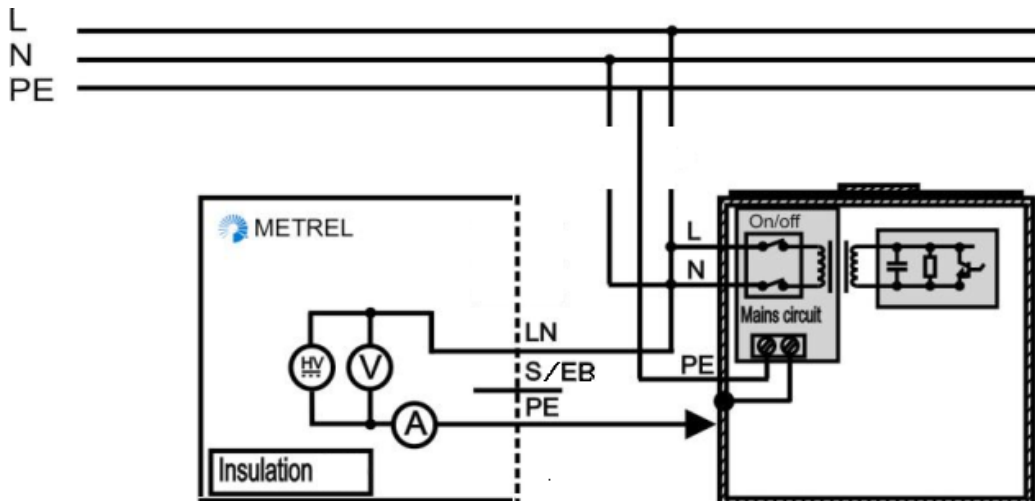


Figure 5.10: Measurement of insulation resistance of fixed installed DUTs of Class I

**Insulation resistance measurement procedure**

- ▶ Select the INSULATION function.
- ▶ Set the test parameters.
- ▶ Connect device under test to the instrument (see **Figure 5.9** and **Figure 5.10**).
- ▶ Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- ▶ Store the result by pressing MEM key (optional).



Figure 5.11: Examples of Insulation resistance measurement results

Displayed results:

Main result ..... Insulation resistance

**Notes:**

- ▶ When S/EB probe is connected during the test then the current through it is also considered.
- ▶ Consider any warning on the display before starting the measurement!
- ▶ Do not touch or disconnect the device under test during the measurement or before it is fully discharged! The message »Udisch ...« will be displayed while the voltage on the device is higher than 10 V!

**5.2.4 Insulation resistance - P**

The insulation resistance test checks the resistance between live conductors and isolated accessible metal parts of the device under test. This test can disclose faults caused by pollution, moisture, deterioration of the insulation material etc.

The instrument measures the insulation resistance between:

- ▶ The (L+N) on test socket and S/EB terminal;
- ▶ LN terminal and S/EB terminal (for fixed installed appliances).

This function is primarily intended for testing Class II appliances and Class II parts of Class I appliances.



Figure 5.12: Insulation resistance - P menu

**Test parameters for Insulation resistance - P measurement**

OUTPUT	Test voltage [250 V, 500 V]
LIMIT	Minimum resistance [0.01 MΩ, 0.10 MΩ, 0,25MΩ, 0.30 MΩ, 0.50 MΩ, 1 MΩ, 2 MΩ, 4 MΩ, 7 MΩ, 10 MΩ, --- MΩ]
TIME	Measuring time [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

**Test circuits for Insulation resistance - P measurement**

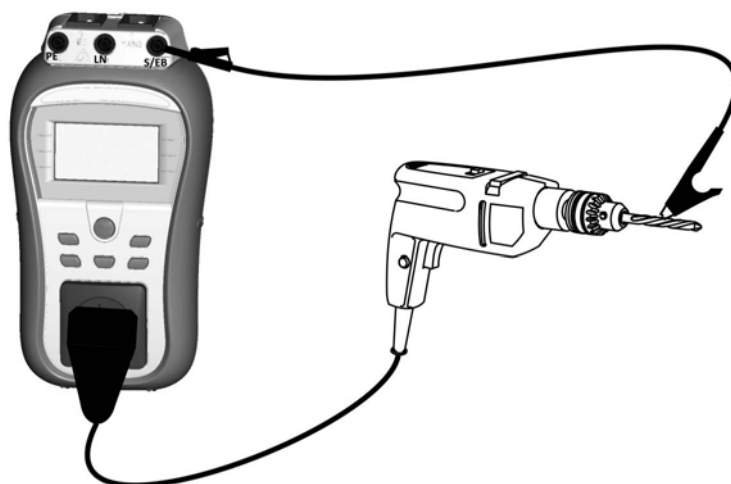


Figure 5.13: Measurement of Insulation resistance - P

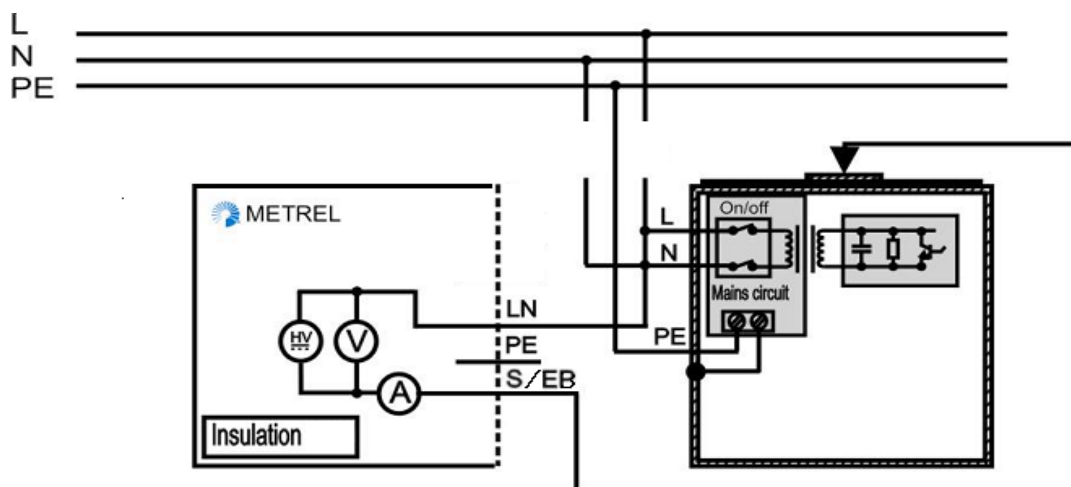


Figure 5.14: Measurement of insulation resistance of fixed installed DUTs

**Insulation resistance - P measurement procedure**

- › Select the INSULATION-P function.
- › Set the test parameters.
- › Connect device under test to the instrument (see *Figures 5.13* and *Figures 5.14*).
- › Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- › Store the result by pressing MEM key (optional).



**Figure 5.15:** Example of insulation resistance - P measurement results

Displayed results:

Main result ..... Insulation resistance (LN – P)

**Notes:**

- › The currents flowing through the PE terminal or PE on test socket will NOT be considered.
- › Consider any warning on the display before starting the measurement!
- › Do not touch / disconnect the device under test during the measurement or before it is fully discharged! The message »UDisch...« will be displayed while the voltage on the device is higher than 10 V!

**5.2.5 Substitute leakage**

Leakage currents between live conductors and accessible metal parts (housing, screws, handles etc.) are checked with this test. Capacitive leakage paths are included in the result too. The test measures the current flowing at a test voltage of 30 VAC and the result is scaled to the value of a nominal mains supply voltage.

The instrument measures the substitute leakage between:

- › The (L+N) on test socket and PE terminal on test socket / (S/EB) terminal;
- › LN terminal and PE terminal / (S/EB) terminal (for fixed installed appliances).

This function is primarily intended for testing Class I appliances.

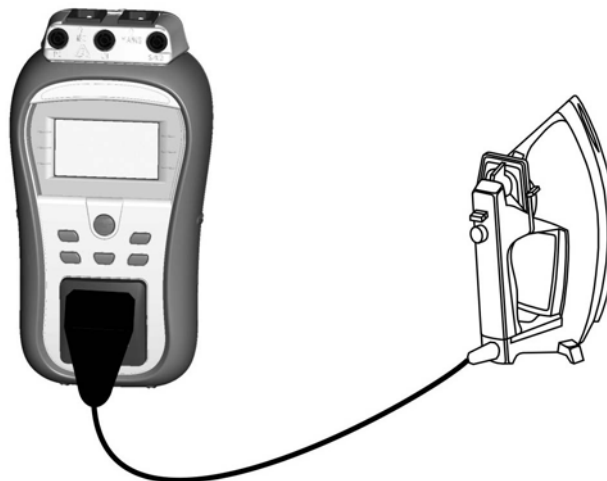


**Figure 5.16:** Substitute leakage menu

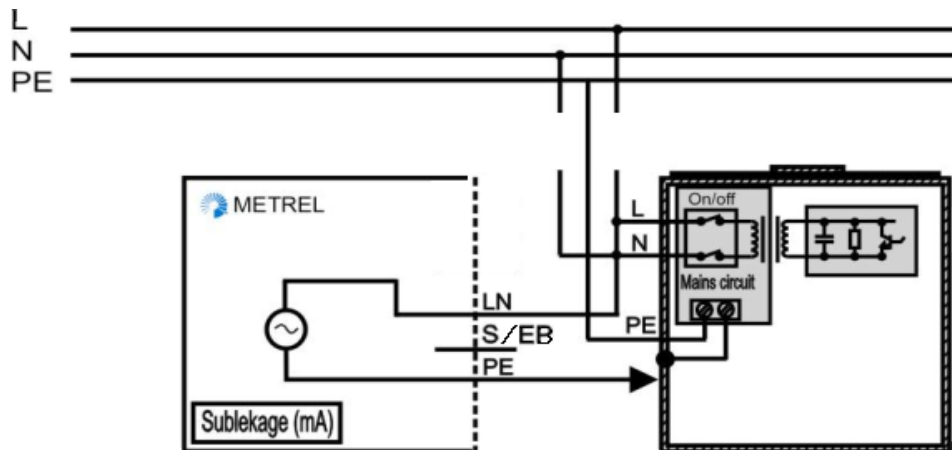
**Test parameters for Substitute leakage current measurement**

OUTPUT	Test voltage [30 V]
LIMIT	<b>Maximum current</b> [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA, 5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, --- mA]
TIME	<b>Measuring time</b> [2s, 3s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

**Test circuits for Substitute leakage current measurement**



**Figure 5.17:** Measurement of Substitute leakage current



**Figure 5.18:** Measurement of substitute leakage current of fixed installed DUTs

**Substitute leakage measurement procedure**

- ▶ Select the SUB. LEAKAGE function.
- ▶ Set the test parameters.
- ▶ Connect device under test to the instrument (see **Figures 5.16** and **Figures 5.17**).
- ▶ Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- ▶ Store the result by pressing MEM key (optional).



**Figure 5.19:** Example of substitute leakage current measurement results

Displayed results:

Main result ..... Substitute leakage current

**Notes:**

- › Consider any displayed warning before starting measurement!
- › When S/EB probe is connected during the test then the current through it is also considered.
- › Substitute leakage result may differ from the leakage current test result. For example, if EM filter capacitors are connected to the phase and neutral conductors, the substitute leakage result can be 2 times higher than the differential leakage result.

### 5.2.6 Substitute leakage - P

Leakage currents between live conductors and isolated accessible metal parts (screws, handles etc.) are checked with this test. Capacitive leakage paths are included in the result too. The test measures the current flowing at a test voltage of 30 V AC and the result is scaled to the value of a nominal mains supply voltage.

The instrument measures the substitute leakage between:

- › The (L+N) on test socket and S/EB terminal;
- › LN terminal and S/EB terminal (for fixed installed appliances).

This function is primarily intended for testing Class II appliances and Class II parts of Class I appliances.

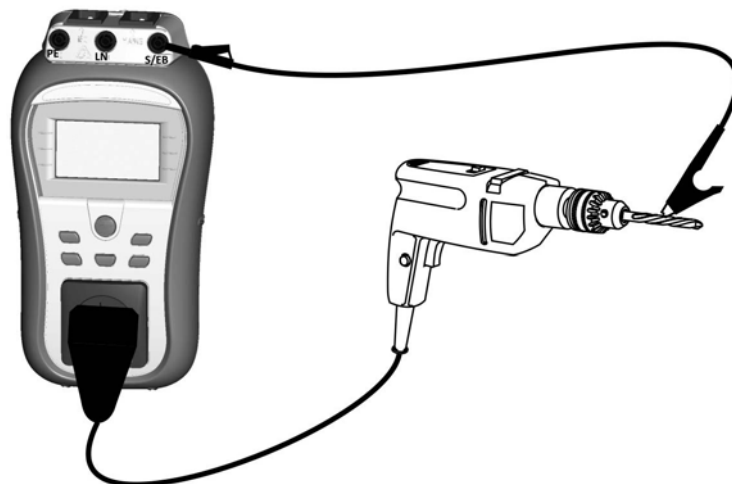


Figure 5.20: Substitute leakage - P menu

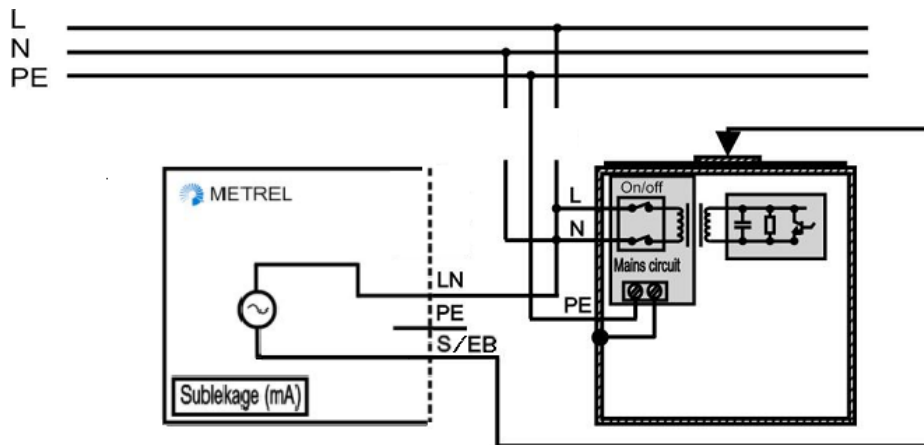
#### Test parameters for substitute leakage - P current measurement

OUTPUT	Test voltage [30 V]
LIMIT	<b>Maximum current</b> [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, --- mA]
TIME	<b>Measuring time</b> [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

#### Test circuits for substitute leakage - P measurement



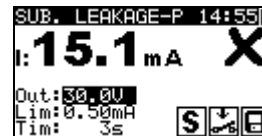
**Figure 5.21:** Measurement of Substitute leakage - P current



**Figure 5.22:** Measurement of substitute leakage of accessible isolated conductive parts of fixed installed DUTs

**Substitute leakage - P measurement procedure**

- › Select the SUB. LEAKAGE-P function.
- › Set the test parameters.
- › Connect device under test to the instrument (see **Figure 5.21** and **Figure 5.22**).
- › Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- › Store the result by pressing MEM key (optional).



**Figure 5.23:** Example of substitute leakage - P current measurement results

Displayed results:

Main result.....Substitute leakage current (LN – P)

**Notes:**

- › Consider any displayed warning before starting measurement!
- › The currents flowing through the PE terminal or PE of the test socket will not be considered.

**5.2.7 Polarity test**

This test checks the polarity of supply cords. The following faults can be detected: L OPEN, N OPEN, PE OPEN, L-N CROSS, L-N SHORT, L-PE SHORT, N-PE SHORT and MULTIPLE FAULT.



Figure 5.24: Polarity test menu

**Test circuit for polarity test**



Figure 5.25: Polarity test of IEC cord

**Polarity test procedure**

- › Select the POLARITY function.
- › Connect the IEC cord to the instrument as shown on **Figure 5.25**.
- › Press the TEST key for measurement.
- › Store the result by pressing MEM key (optional).



Figure 5.26: Examples of polarity test result

Displayed results:

Main result ..... PASS/FAIL, description of fault

**Note:**

- › Consider any displayed warnings before starting test!

**5.2.8 Differential leakage**

The purpose of this test is to determine the sum of all leakages flowing from the live conductors to the earth. The differential method allows measuring the full and true leakage current, even if there are parallel current paths from the DUT to ground.

The instrument measures:

- › The differential leakage of the DUT connected to the instrument test socket.

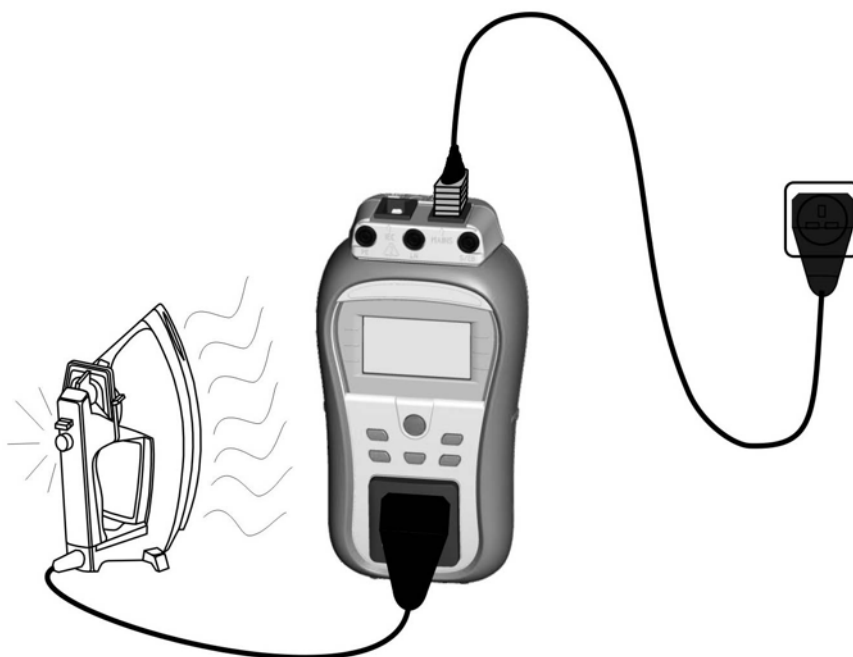


**Figure 5.27:** Differential leakage current menu

### Test parameters for differential leakage current measurement

OUTPUT	Test voltage [MAINS voltage]
LIMIT	<b>Maximum current</b> [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, 4.00 mA, 4.50 mA, 5.00 mA, 5.50 mA, 6.00 mA, 7.00 mA, 8.00 mA, 9.00 mA, 10.0 mA, 15.0 mA, --- mA]
TIME	<b>Measuring time</b> [2s, 3s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

### Test circuit for differential leakage current measurement



**Figure 5.28:** Measurement of differential current

### Differential current measurement procedure

- › Select the DIFF. LEAKAGE function.
- › Set the test parameters.
- › Connect device under test to the instrument (see **Figure 5.28**).
- › Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- › Store the result by pressing MEM key (optional).



Figure 5.29: Examples of differential current measurement result

Displayed results:

Main result I ..... Differential leakage current

Sub-result P.....Apparent power

**Notes:**

- › For this test the instrument must be connected to the mains voltage.
- › During the test, mains voltage is connected to the DUT. If DUT contains moving parts, make sure that it is safely mounted or protected to prevent possible danger to the operator or damage to the DUT or surrounding environment!
- › Consider any displayed warning before starting measurement!
- › The instrument automatically changes L and N polarity of connected DUT during the test.
- › Measurement can be aborted by pressing ESC key.

**5.2.9 Touch leakage**

This test determines the current that would flow if a person touches accessible conductive parts of the DUT.

The instrument measures:

- › The touch leakage current flowing through the S/EB probe into earth.

The DUT can be powered from the test socket or directly from the installation (fixed installed equipment).



Figure 5.30: Touch leakage menu

**Test parameters for touch leakage current measurement**

OUTPUT	Test voltage [MAINS voltage]
LIMIT	<b>Maximum current</b> [0.25 mA, 0.50 mA, 0.75 mA, 1.00 mA, 1.50 mA, 2.00 mA, 2.25 mA, 2.50 mA, 3.50 mA, --- mA]
TIME	<b>Measuring time</b> [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

**Test circuits for touch leakage current measurement**

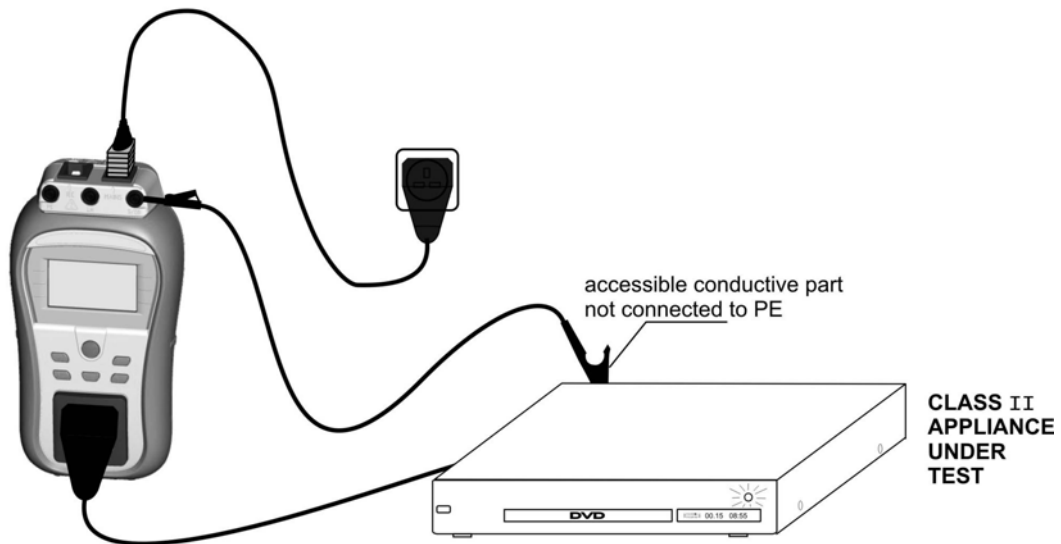


Figure 5.31: Measurement of touch leakage current

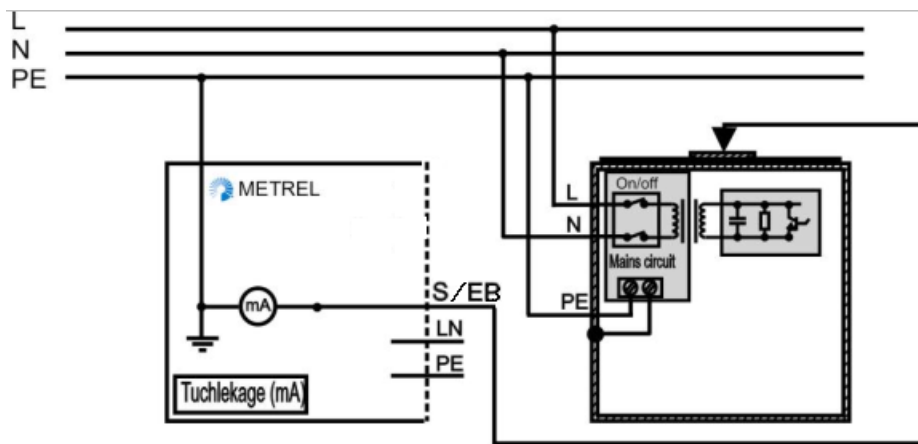


Figure 5.32: Measurement of touch leakage current on a fixed installed DUT

**Touch leakage current measurement procedure**

- › Select the TOUCH LEAKAGE function.
- › Set the test parameters.
- › Connect device under test to the instrument (see **Figure 5.31** and **Figure 5.32**).
- › Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- › Store the result by pressing MEM key (optional).



Figure 5.33: Examples of touch leakage current measurement results

Displayed results:  
Main result I ..... Touch leakage current

Sub-result P.....Apparent power

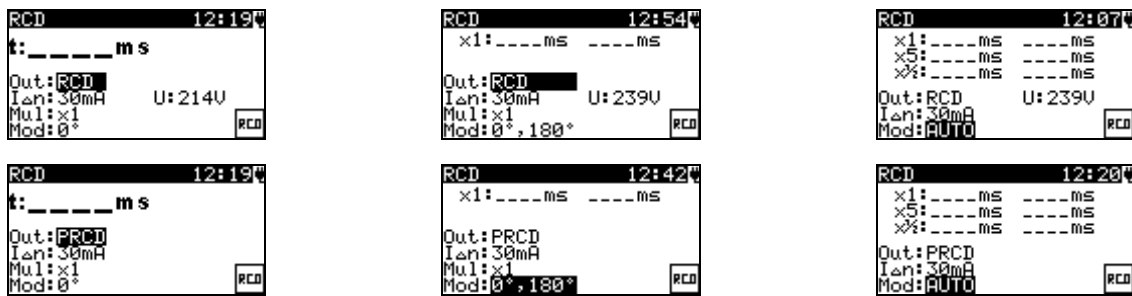
**Notes:**

- ▶ For this test the instrument must be connected to the mains voltage.
- ▶ During the test, mains voltage is connected to the DUT. If DUT contains moving parts, make sure that it is safely mounted or protected to prevent possible danger to the operator or damage to the DUT or surrounding environment!
- ▶ Consider any displayed warning before starting measurement!
- ▶ The instrument automatically changes L and N polarity of connected DUT during the test.
- ▶ Measurement can be aborted by pressing ESC key.

**5.2.10 (P)RCD test**

The purpose of this test is to ensure the proper operation of residual current devices (RCD) built into appliances / installations and portable residual current devices (PRCD). Trip-out time measurement verifies the sensitivity of a (P)RCD at selected residual currents.

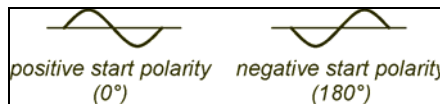
The (P)RCD test is performed via the instrument mains supply input.



**Figure 5.34:** (P)RCD single and auto test menus

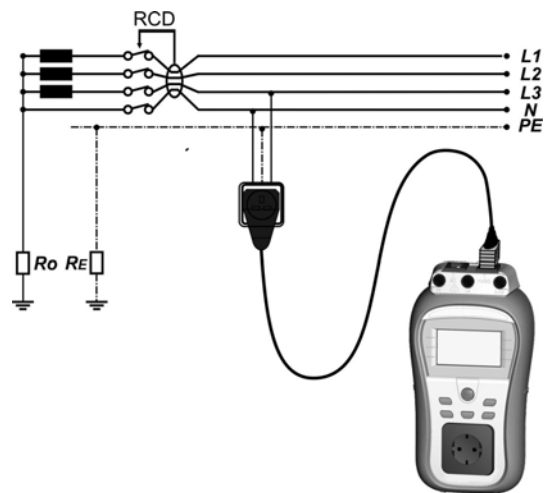
**Test parameters for (P)RCD test**

Test	Test function [RCD, PRCD]
$I_{\Delta N}$	Rated residual current [10 mA, 15 mA, 30 mA]
Mul	Test current multiplier $I_{\Delta N}$ [x 1/2, x 1, x 5]
Mod	(P)RCD test mode [(0°, 180°, (0°,180°), AUTO)]

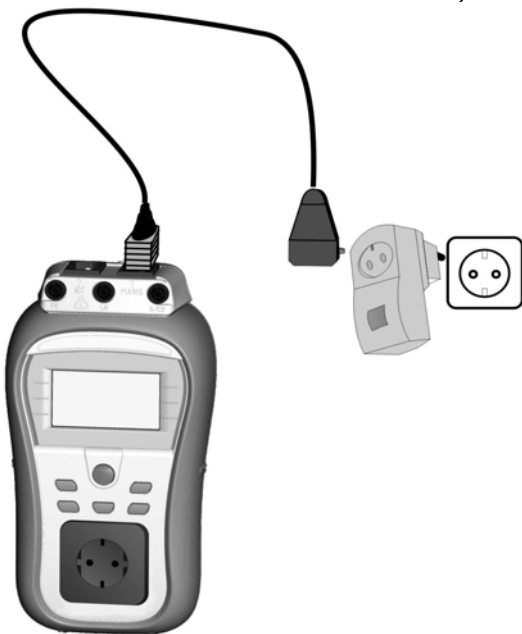


**Figure 5.35:** (P)RCD test current starting polarities 0°, 180°

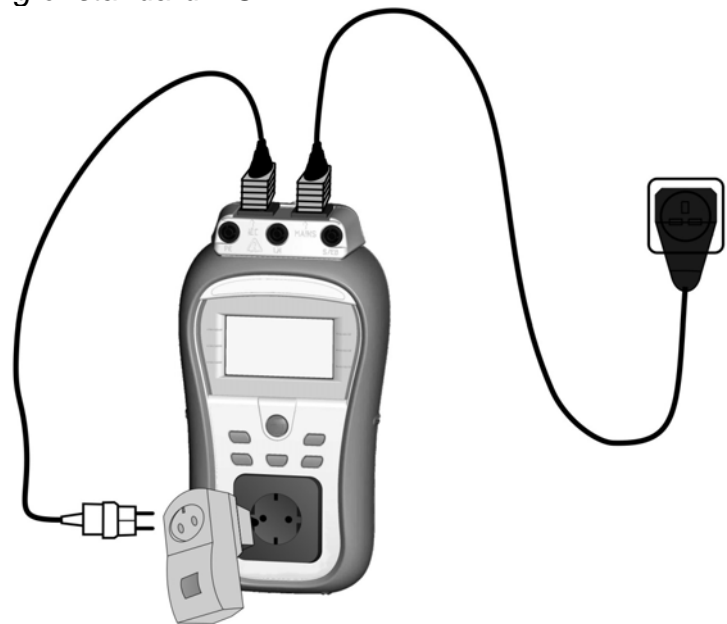
**Test circuits for testing RCD and PRCD**



a) Testing of standard RCD



b) Testing of PRCD via mains socket



c) Testing of PRCD via test socket

**Figure 5.36:** Testing of RCD and PRCD

**5.2.10.1 (P)RCD single test**

In single test a fast (P)RCD test with selected test current and with one or both starting polarities is performed.

## Trip-out time measurement procedure

### Measuring PRCD

- › Select the RCD test function.
- › Select test mode.
- › Set test parameters.
- › Connect tested PRCD / device to an external voltage socket. Connect the IEC cord to the instrument's MAINS terminal and PRCD (see **Figure 5.36b**).
- › Depending on the type of PRCD, it may be necessary to manually switch it on.
- › Press the TEST key to perform measurement.

If both starting polarities are selected:

- › Reactivate tested PRCD.
- › Store the result by pressing MEM key (optional).

or

- › Select the PRCD test function.
- › Select test mode.
- › Set test parameters.
- › Connect tested PRCD between test socket and IEC connector of the DeltaGT (see **Figure 5.36c**), and connect instrument's MAINS terminal to an external voltage socket.
- › Depending on the type of PRCD, it may be necessary to manually switch it on.
- › Press the TEST key to perform measurement.

If both starting polarities are selected:

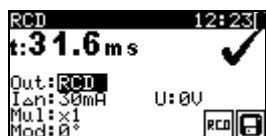
- › Reactivate tested PRCD.
- › Store the result by pressing MEM key (optional).

### Measuring RCD

- › Select the RCD test function.
- › Select test mode.
- › Set test parameters.
- › Connect the DeltaGT MAINS terminal to mains socket protected by tested RCD (see Figure 5.36a).
- › Depending on the type of PRCD, it may be necessary to manually switch it on.
- › Press the TEST key to perform measurement.

If both starting polarities are selected:

- › Reactivate tested RCD.
- › Store the result by pressing MEM key (optional).



**Figure 5.37:** Examples of (P)RCD single test results

Displayed results:

Main result(s) ..... trip out time(s) at selected starting polarity

U ..... voltage  $U_{L-PE}$

#### 5.2.10.2 Automatic (P)RCD test

(P)RCD autotest function is intended to perform a complete (P)RCD analysis (trip-out times at different residual currents and starting polarity phases) .

### (P)RCD autotest procedure


(P)RCD Autotest steps	Notes
<ul style="list-style-type: none"> <li>› Select the RCD (PRCD) test function.</li> <li>› Set AUTO mode.</li> <li>› Select test parameters.</li> <li>› <b>PRCD:</b> Connect tested PRCD / device to an external voltage socket. Connect the IEC cord to the instrument's MAINS terminal and PRCD (see <b>Figure 5.36b</b>). Or connect tested PRCD between test socket and IEC connector of the DeltaGT. Connect the instrument to mains voltage (see <b>Figure 5.36c</b>). Depending on the type of PRCD, it may be necessary to manually switch it on.</li> <li>› <b>RCD:</b> Connect the DeltaGT MAINS terminal to mains socket protected by tested RCD (see <b>Figure 5.36a</b>).</li> <li>› Press the TEST key</li> </ul>	
<ul style="list-style-type: none"> <li>› Test with <math>I_{\Delta N}</math>, <math>0^\circ</math> (step 1).</li> </ul>	(P)RCD should trip-out
<ul style="list-style-type: none"> <li>› Re-activate (P)RCD.</li> <li>› Test with <math>I_{\Delta N}</math>, <math>180^\circ</math> (step 2).</li> </ul>	(P)RCD should trip-out
<ul style="list-style-type: none"> <li>› Re-activate (P)RCD.</li> <li>› Test with <math>5 \times I_{\Delta N}</math>, <math>0^\circ</math> (step 3).</li> </ul>	(P)RCD should trip-out
<ul style="list-style-type: none"> <li>› Re-activate (P)RCD.</li> <li>› Test with <math>5 \times I_{\Delta N}</math>, <math>180^\circ</math> (step 4).</li> </ul>	(P)RCD should trip-out
<ul style="list-style-type: none"> <li>› Re-activate (P)RCD.</li> <li>› Test with <math>\frac{1}{2} \times I_{\Delta N}</math>, <math>0^\circ</math> (step 5).</li> </ul>	(P)RCD should not trip-out
<ul style="list-style-type: none"> <li>› Test with <math>\frac{1}{2} \times I_{\Delta N}</math>, <math>180^\circ</math> (step 6).</li> </ul>	(P)RCD should not trip-out End of test.

Displayed results:

Main results ..... trip-out times at different currents / starting polarities

U ..... voltage  $U_{L-PE}$

#### Notes:

- › Consider any displayed warning before starting measurement! The  symbol means that the polarity of the mains cord should be changed.
- › Mains voltage is applied to the (P)RCD under test. Do not touch the equipment under test or the test cord during the test.

### 5.2.11 Power test

The DUT's power consumption is measured in this test. The apparent power is a useful indication of proper operation of the appliance.



Figure 5.38: Power test menu

**Test parameters for the Power test**

OUTPUT	Test voltage [MAINS voltage]
TIME	<b>Measuring time</b> [2 s, 3 s, 5 s, 10 s, 30 s, 60 s, 120 s, --- s (continuous measurement)]

**Test circuit for the power test**

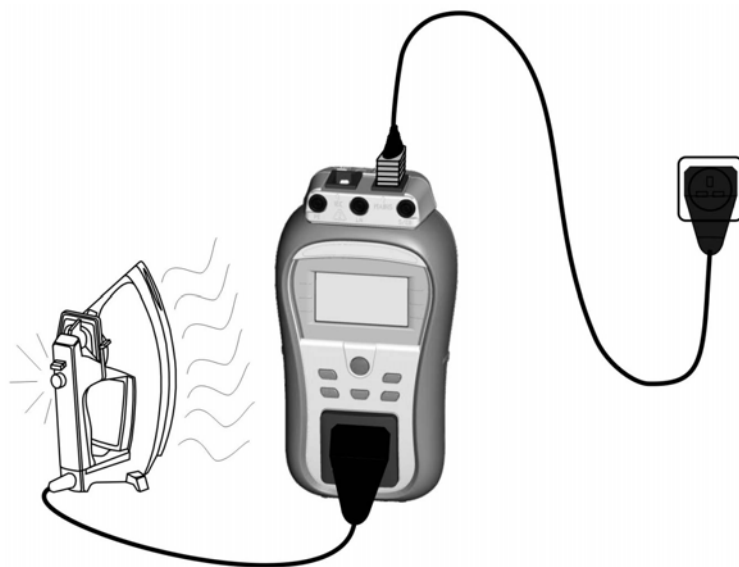


Figure 5.39: Power test

**Functional test procedure**

- › Select the POWER function.
- › Set test parameters.
- › Connect device under test to the instrument’s test socket and switch it on (see figure 5.39).
- › Connect the instrument to mains voltage.
- › Press the TEST key for measurement. To stop continuous measurement press TEST key once again.
- › Store the result by pressing MEM key (optional).



Figure 5.40: Example of apparent power measurement result

Displayed results:  
Main result ..... Apparent power

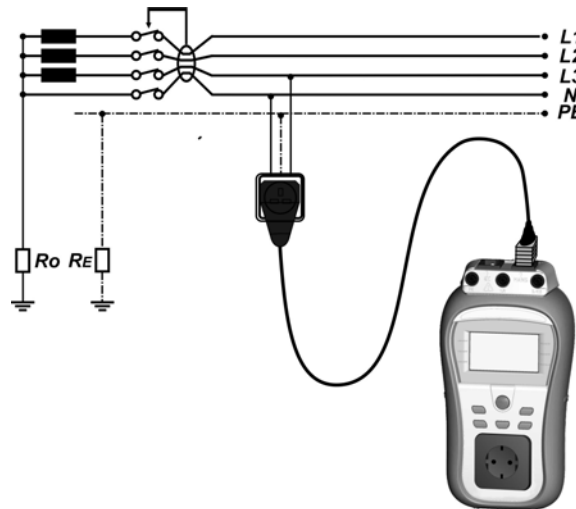
**Notes:**

- › For this test the instrument must be connected to the mains voltage.
- › During the test, mains voltage is connected to the DUT. If DUT contains moving parts, make sure that it is safely mounted or protected to prevent possible danger to the operator or damage to the DUT or surrounding environment!
- › Consider any displayed warning before starting measurement!
- › Continuous measurement is for safety reasons automatically stopped after 2 minutes if a current higher than 10 A is flowing through the DUT and the DeltaGT during Power measurement.

**5.2.12 Voltage TRMS**

In this function the voltage across the MAINS terminal is measured continuously.

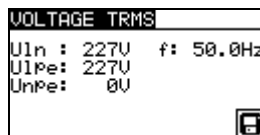
**Test circuit for voltage measurement**



*Figure 5.42: Voltage measurement with the IEC cord*

**Voltage TRMS procedure**

- › Select the VOLTAGE TRMS function.
- › Connect the IEC cord to the instrument’s MAINS terminal and to the external mains socket as shown on figure 5.42.
- › Store the result by pressing MEM key (optional).



*Figure 5.43: Voltage TRMS test result*

Displayed results:

Main result ..... Voltage

f..... Frequency

**Warning:**

- › Only for voltage range from 80 V to 300 V!

### 5.2.13 Functional test

Functional test is the simplest way to ensure that the appliance is working properly.

**Note:**

- › This test should only be performed once the DUT has passed all other tests applicable to this type of appliances.

**Scope of test**

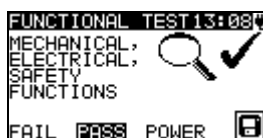
Check following items while the appliance is operating:

- › RCDs and other disconnection devices.
- › How hot the appliance becomes during operation.
- › Rotating parts, fans, etc.
- › Power consumption.
- › Lamps and indicators.
- › Etc.

Especially safety relevant functions should be checked.

**Functional test procedure**

- › Select the FUNCTIONAL TEST function.
- › Plug the device under test to the instrument's test socket and supply the instrument.
- › Select and start **POWER** sub-function. Switch on the appliance and check that it operates correctly.
- › Select PASS or FAIL according to the result of functional test.
- › Store the result by pressing MEM key (optional).



**Figure 5.44:** Functional test menu

## 6 Autotest sequences

Autotest is the fastest and easiest way to test appliances. During the autotest, pre-programmed measurements run automatically in a sequential order. The complete autotest results can be stored together with the associated appliance ID and appliance NAME.

### 6.1 VDE organizer setup menu

Select VDE Organizer in Main menu.

In the first step the appliance type, protective measures and additional protection should be set.

**Appliance types** are:

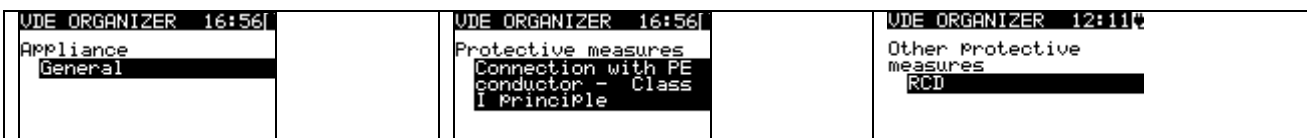
- General;
- Appliances with heating elements.
- IEC leads, multiple outlets without electronic parts;

**Protective measures** are:

- Accessible conductive part is connected to protective conductor (Class I principle);
- Accessible conductive part is protected by isolation (Class II principle) or SELV / PELV measures;
- Combined Class I and Class II / SELV / PELV measures;
- There are no accessible conductive parts;
- Device is a Class III device.

**Additional protection:**

- Additional protection is provided by (portable) RCDs;
- No additional protection.



**Figure 6.1:** Selection of appliance type and protective measures

Keys:

▲ / ▼	Selects Organizer option. Selected option is highlighted.
ESC	Cancels VDE sequence and returns to Main menu.
TEST	Confirms selection and proceeds to next step.

After the appliance type and means of protection are set the appropriate test sequence can be started.

### 6.1.1 Carrying out a test sequence set with VDE Organizer

General meaning of keys during VDE Organizer autotest sequence:

<b>▲/▼</b>	Sets Organizer option or set value in selected (highlighted) item.
<b>ESC</b>	Cancels VDE sequence and returns to Main menu.
<b>TEST</b>	Starts / repeats selected measurement or proceeds to next step.

After the test sequence is finished the instrument proceeds to the 'Autotest Result' menu. For more information refer to chapter 7 *Working with Autotest results*.

**Note:**

- If any of the inspections are marked as failed or if any test fails the test sequence is stopped and the instrument automatically goes to the **Result** menu.

#### 6.1.1.1 Visual inspection

Measurement is described in chapter 5.2.1 *Visual inspection*.



**Figure 6.2:** VDE Organizer – Visual inspection menu

Options in Visual inspection menu:

**PASS / FAIL** To be applied manually.

#### 6.1.1.2 Earth continuity resistance measurement

The test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter 5.2.2 *Earth continuity resistance*.



**Figure 6.3:** VDE Organizer – Earth continuity starting screen

Options in Earth continuity starting screen:

<b>▲/▼</b>	Sets power cord length.
------------	-------------------------

**Note:**

- Earth continuity resistance limit is automatically set on base of set cord length.



**Figure 6.4:** VDE Organizer – Earth continuity result screen

Options in Earth continuity result screen:

**NEXT** Proceeds to next step.

**REPEAT** Repeats the test (in case of multiple earthed points). Highest result will be stored.

### 6.1.1.3 Insulation resistance measurement

This test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter 5.2.3 *Insulation resistance*.

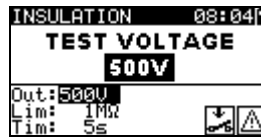


Figure 6.5: VDE Organizer – Insulation resistance starting screen

Options in insulation resistance starting screen:

- NO** To be set if insulation test is not applicable
- YES** To be set if insulation test is applicable
- 500 V** Standard test voltage
- 250 V** To be set if overvoltage protection devices are installed or SELV/ PELV protection measures.



Figure 6.6: VDE Organizer – Insulation resistance result screen

There are no special options to be set in the insulation resistance result screen.

### 6.1.1.4 Selection of leakage current test method

The leakage test is offered if it is applicable according to the VDE Organizer setting. If more test methods are possible the applicable leakage current test method must be set first.

Options are **Differential leakage** and **Substitute leakage**.

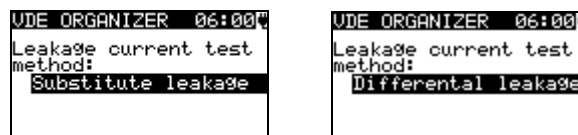


Figure 6.7: Leakage current test method selection screen

### 6.1.1.5 Substitute leakage measurement

The measurement is described in chapter 5.2.5 *Substitute leakage*.

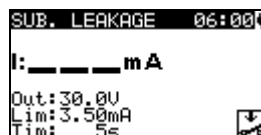


Figure 6.8: VDE Organizer – Substitute leakage starting screen

Options if **Appliances with heating elements** is set:

▲/▼	Sets power of heating elements.
-----	---------------------------------

**Note:**

- The leakage current limit is automatically set on base of set appliance power.

There are no special options to be set if other Appliance type is set.



**Figure 6.9:** VDE Organizer – Substitute leakage result screen

There are no special options to be set in the Substitute leakage result screen.

### 6.1.1.6 Differential leakage measurement

The measurement is described in chapter 5.2.8 *Differential leakage*.



**Figure 6.10:** VDE Organizer – Differential leakage starting screen

Options if **Appliances with heating elements** is set:

▲/▼	Sets power of heating elements.
-----	---------------------------------

**Note:**

- The leakage current limit is automatically set on base of set appliance power.

There are no special options to be set if other Appliance type is set.

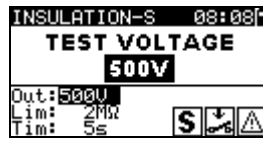


**Figure 6.11:** VDE Organizer – Differential leakage result screen

There are no special options to be set in the Differential leakage result screen.

### 6.1.1.7 Insulation resistance - P measurement

This test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter 5.2.4 *Insulation resistance - P*.



**Figure 6.12:** VDE Organizer autotest – Insulation resistance - P starting screen

Options in Insulation resistance-P starting screen:

<b>NO</b>	To be set if insulation test is not applicable
<b>YES</b>	To be set if insulation test is applicable
<b>500 V</b>	Standard test voltage
<b>250 V</b>	To be set if overvoltage protection devices are installed or SELV/ PELV protection measures.



**Figure 6.13:** VDE Organizer – Insulation resistance - P result screen

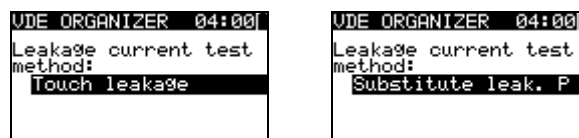
Options in Insulation resistance - P result screen:

<b>NEXT</b>	Proceeds with the next measurement.
<b>REPEAT</b>	Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Lowest result will be stored.

### 6.1.1.8 Selection of touch leakage current test method

The touch leakage test is offered if it is applicable according to the VDE Organizer setting. If more test methods are possible the applicable touch leakage current test method must be set first.

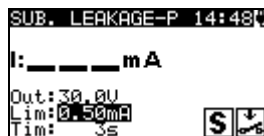
Options are **Touch leakage** and **Substitute leakage-P**.



**Figure 6.14:** Touch leakage current test method selection screen

### 6.1.1.9 Substitute leakage - P current measurement

The measurement is described in chapter 5.2.6 *Substitute leakage - P*.



**Figure 6.15:** VDE Organizer – Substitute leakage - P starting screen

There are no special options in the Substitute leakage - P starting screen.



**Figure 6.16:** VDE Organizer – Substitute leakage - P result screen

Options in Substitute leakage - P result screen:

**NEXT** Proceeds with the next measurement.

**REPEAT** Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

#### 6.1.1.10 Touch leakage measurement

The measurement is described in chapter 5.2.9 *Touch Leakage*.



**Figure 6.17:** VDE Organizer – Touch leakage starting screen

There are no special options in the Touch leakage - starting screen.



**Figure 6.18:** VDE Organizer – Touch leakage result screen

Options in Touch leakage result screen:

**NEXT** Proceeds with the next measurement.

**REPEAT** Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

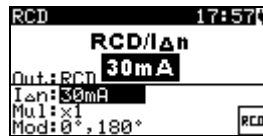
#### 6.1.1.11 RCD test

This test is offered if it is applicable according to the VDE Organizer setting. The measurement is described in chapter 5.2.10 *(P)RCD test*.

Options in VDE organizer starting screen:

**NO** To be set if RCD test is not applicable.

**RCD** To be set if RCD test is applicable.



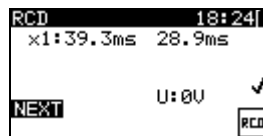
**Figure 6.19:** VDE Organizer –RCD starting screen

Options in RCD starting screen:

▲/▼ Sets nominal RCD value

**Note:**

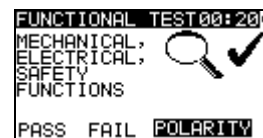
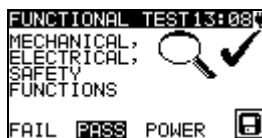
- The test mode is automatically set to Single test,  $1xI_{\Delta n}$ , both polarities.



**Figure 6.20:** VDE Organizer –RCD result screen

There are no special options in the RCD result screen.

### 6.1.1.12 Functional test



**Figure 6.21:** VDE Organizer – Functional test result screens

Options in Functional test result screen:

**PASS / FAIL** To be applied manually.

Option if **General** or **Appliance with heating elements** is set:

**POWER** Starts Power test. The measurement is described in chapter 5.2.11  
*Power test.*

Option if **IEC leads, multiple outlets without electronic parts** is set:

**POLARITY** Starts Polarity test. The measurement is described in chapter 5.2.7  
*Polarity test*

**Note:**

- After Power or Polarity test is completed, ESC key should be pressed to return to Functional test result screen.

## 6.2 Custom autotest

In the autotest custom menu user-defined autotest procedures can be performed via the PC SW PATLink PRO. Up to 50 custom autotest sequences can be pre-programmed in this autotest mode.

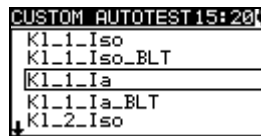
Commonly used pre-programmed autotest sequences are added to the list by default.

The custom sequences can be also uploaded from the PC via PC SW PATLink PRO. Refer to chapter 8 *Communication* for more information.

New custom sequences can be also uploaded from the VDE Organizer. Refer to chapter 7 *Working with autotest results* for more information.

The pre-programmed sequences can be restored to default sequences by selecting *Initial settings* in *Setup menu*.

Select Custom Autotest function in Main menu.



**Figure 6.22:** Custom autotest menu

Keys:

▼ / ▲	Selects the custom autotest.
<b>START</b>	Starts the selected custom autotest. See chapter 6.5 <i>Carrying out autotest sequences (Code, Simple and Custom)</i> .
<b>ESC</b>	Returns to Main menu.

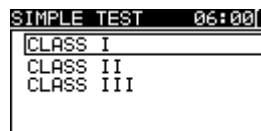
**Note:**

- If more than 50 autotests are saved, »**Out of custom autotest memory**« message is displayed.

## 6.3 Simple test

Simple test sequences are commonly used pre-programmed autotest sequences with possibility of fast testing. **Fast testing mode** can be enabled in **Test speed setup** function in **Setup menu**. Refer to chapter 4.8.4 *Test speed setup* for more information.

Select Simple test function in Main menu.



**Figure 6.23:** Simple test menu

Keys:

▼ / ▲	Selects the test sequence from the list
<b>START</b>	Starts the selected test. See chapter 6.5 <i>Carrying out autotest sequences (Code, Simple and Custom)</i> .
<b>ESC</b>	Returns to Main menu.

**Note:**

- Test functions and limits of Simple tests are listed in *Appendix C*

### 6.4 Code Autotest

Code Autotest menu supports operation with pre-defined test codes, barcodes and RFID tags.

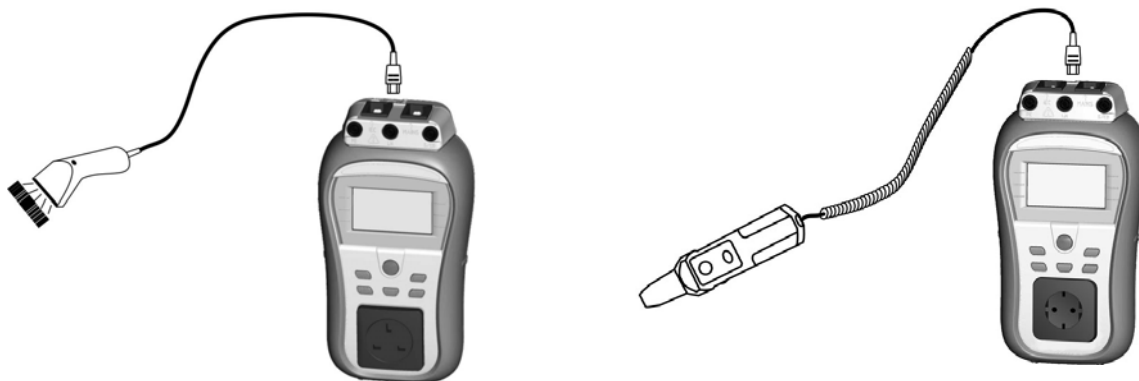
The instrument supports the following functions:

- manual selection of pre-defined autotest shortcut codes;
- reading pre-defined autotest shortcut codes from barcode labels;
- reading pre-defined autotest shortcut codes from RFID tags;
- reading appliance ID numbers from barcode labels;
- reading appliance ID numbers from RFID tags;
- reading pre-defined autotest shortcut codes and appliance ID numbers from barcode labels (double barcode format).
- programming empty RFID tags.

Refer to *Appendix A Barcode formats* for more information regarding barcode labels.

#### Reading a Code autotest sequence (with barcode scanner, RFID reader/writer or manually)

Connect barcode scanner or RFID reader/writer to the instrument RS232 / PS2 connector first.



**Figure 6.24:** Connection of the barcode scanner and RFID reader/writer

Set RS 232 communication port and baud rate to 9600 bps using **Communication** function in **Setup menu**. Select Code Autotest in Main menu. The latest received or set autotest sequence name and its code is displayed. A new autotest sequence (received from the barcode scanner or RFID reader/writer) will be accepted by the instrument (refer to *Appendix* for available autotest sequences and its codes). A successful receive of the barcode or RFID tag is confirmed by two short confirmation beeps.



**Figure 6.25:** Code autotest menu

The autotest sequence and its code can also be set manually.

Keys:

▼ / ▲	Manually selects autotest sequence by setting its code.
<b>TEST</b>	Starts selected autotest sequence. Refer to chapter 6.5 <i>Carrying out autotest sequences (Code, Simple and Custom)</i> .
<b>ESC</b>	Returns to Main menu.

## Reading appliance ID number with barcode scanner or RFID reader/writer

When the instrument is in the Save results menu, appliance ID can be scanned from a barcode label with the barcode reader or can be read from RFID tag with the RFID reader/writer. A successful receive of the barcode or RFID tag is confirmed by two short confirmation beeps.

## 6.5 Carrying out autotest sequences (Code, Simple and Custom)

General meaning of keys during Code, Simple and Custom autotest sequences:

<b>TAB, ▲/▼</b>	Set option. Set limit value in selected (highlighted) item.
<b>ESC</b>	Cancels autotest sequence and returns to the autotest menu (Code, Simple or Custom) without changes.
<b>TEST</b>	Starts / repeats selected measurement or proceeds to the next step.

### Notes

- If any of the inspections are marked as failed or if any test fails the test sequence is stopped and the instrument automatically goes to the **Result** menu.
- If a test parameter (limit, duration, output voltage) is changed the setup is valid only for the particular test.
- If the test limit, output voltage or test duration is changed in Code autotest sequence the autotest code will not be stored (as the settings do not correspond with the code anymore).

### 6.5.1 Visual inspection

Measurement is described in chapter 5.2.1 *Visual inspection*.



Figure 6.26: Visual test menu

Options in Visual inspection:

**PASS / FAIL** To be applied manually.

### 6.5.2 Earth continuity resistance measurement

The test is offered if it is applicable according to the autotest setting. The Earth continuity starting screen is displayed first. Measurement and options in Earth continuity starting screen are described in chapter 5.2.2 *Earth continuity resistance*.



Figure 6.27: Earth continuity starting screen

After the measurement is carried out the Earth continuity result screen is displayed.



**Figure 6.28:** Earth continuity result screen

Options in Earth continuity result screen:

- NEXT** Proceeds to next step.
- REPEAT** Repeat the test (use in case of multiple earthed points). Highest result will be stored.

### 6.5.3 Insulation resistance measurement

The test is offered if it is applicable according to the autotest setting. The Insulation starting screen is displayed first. Measurement and options in Insulation starting screen are described in chapter 5.2.3 *Insulation resistance*.



**Figure 6.29:** Insulation resistance starting screen

After the measurement is carried out the Insulation result screen is displayed.



**Figure 6.30:** Insulation result screen

There are no special options to be set in the Insulation resistance result screen.

### 6.5.4 Substitute leakage measurement

The test is offered if it is applicable according to the autotest setting. The Substitute leakage current starting screen is displayed first. Measurement and options in Substitute leakage starting screen are described in chapter 5.2.5 *Substitute leakage*.



**Figure 6.31:** Substitute leakage starting screen

After the measurement is carried out the Substitute leakage result screen is displayed.



**Figure 6.32:** Substitute leakage result screen

There are no special options to be set in the Substitute leakage result screen.

### 6.5.5 Differential leakage measurement

The test is offered if it is applicable according to the autotest setting. The Differential leakage current starting screen is displayed first. Measurement and options in Differential leakage starting screen are described in chapter 5.2.8 *Differential leakage*.



**Figure 6.33:** Differential leakage starting screen

After the measurement is carried out the Differential leakage result screen is displayed.



**Figure 6.34:** Differential leakage result screen

There are no special options to be set in the Differential leakage result screen.

### 6.5.6 Insulation resistance - P measurement

The test is offered if it is applicable according to the autotest setting. The Insulation resistance - P starting screen is displayed first. Measurement and options in Insulation resistance - P starting screen are described in chapter 5.2.4 *Insulation resistance - P*.



**Figure 6.35:** Insulation resistance - P starting screen

After the measurement is carried out the Insulation resistance - P result screen is displayed.



**Figure 6.36:** Insulation resistance - P result screen

Options in Insulation resistance - P result screen:

- NEXT** Proceeds with the next measurement.
- REPEAT** Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Lowest result will be stored.

### 6.5.7 Substitute Leakage - P measurement

The test is offered if it is applicable according to the autotest setting. The Substitute leakage - P starting screen is displayed first. Measurement and options in Substitute leakage - P starting screen are described in chapter 5.2.6 *Substitute leakage - P*.



**Figure 6.37:** Substitute leakage - P starting screen

After the measurement is carried out the Substitute leakage - P result screen is displayed.



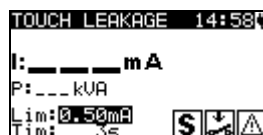
**Figure 6.38:** Substitute leakage - P result screen

Options in Substitute leakage - P result screen:

- NEXT** Proceeds with the next measurement.
- REPEAT** Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

### 6.5.8 Touch Leakage measurement

The test is offered if it is applicable according to the autotest setting. The Touch leakage - starting screen is displayed first. Measurement and options in Touch leakage screen are described in chapter 5.2.9 *Touch leakage*.



**Figure 6.39:** Touch leakage starting screen

After the measurement is carried out the Touch leakage result screen is displayed.



**Figure 6.40:** Touch leakage result screen

Options in Touch leakage result screen:

- NEXT** Proceeds with the next measurement.
- REPEAT** Repeats the test (use in case of multiple isolated / SELV / PELV accessible points). Highest result will be stored.

### 6.5.9 (P)RCD test

The test is offered if it is applicable according to the autotest setting. The (P)RCD test starting screen is displayed first.

Measurement and options in (P)RCD test starting screen are described in chapter 5.2.10 RCD test.

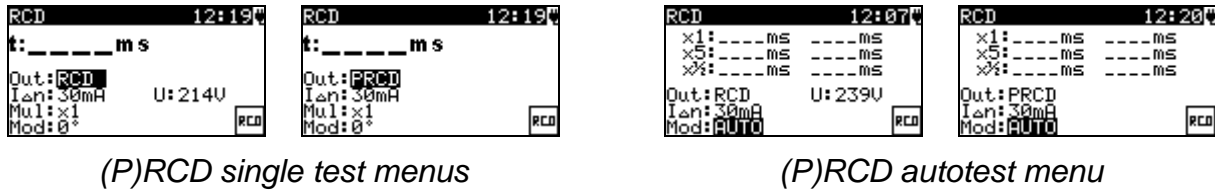


Figure 6.41: (P)RCD test starting screen

After the measurement is carried out the (P)RCD test result screen is displayed.

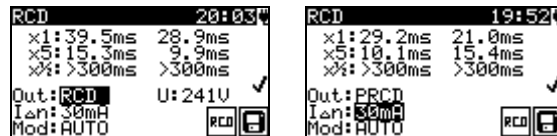


Figure 6.42: Example of Custom / Code Autotest – (P)RCD test result screen

There are no special options in the (P)RCD result screen.

### 6.5.10 Polarity test

The test is offered if it is applicable according to the autotest setting. The Polarity test starting screen is displayed first. Measurement and options in Polarity test starting screen are described in chapter 5.2.7 Polarity test.



Figure 6.43: Polarity test starting screen

After the measurement is carried out the Polarity test result screen is displayed.



Figure 6.44: Polarity test result screen

There are no special options in the Polarity test starting screen.

### 6.5.11 Power test

The test is offered if it is applicable according to the autotest setting. The Power starting screen is displayed first. Measurement and options in Power starting screen are described in chapter 5.2.11 *Power test*.



**Figure 6.45:** Power starting screen

After the measurement is carried out the Power result screen is displayed.

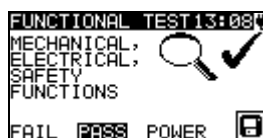


**Figure 6.46:** Power result screen

There are no special options to be set in the Power result screen.

### 6.5.12 Functional test

The test is offered if it is applicable according to the autotest setting. The Functional test starting screen is displayed first. For more information regarding measurement and test parameters see chapter 5.2.13 *Functional test*.



**Figure 6.47:** Functional result screens

Options in Functional test result screen:

- PASS / FAIL** To be applied manually.
- POWER** Starts Power test.

## 6.6 Handling autotest results

After the Code, Simple or Custom autotest is finished, the Main autotest result screen will be displayed including an overall ✓ / ✗ (PASS / FAIL) indication.



Figure 6.48: Main autotest result screen

Options in Autotest results screen:

- VIEW RESULTS** Views individual results.
- NEW TEST** Returns to Code, Simple or Custom menu.
- SAVE RESULTS** Saves Autotest results.  
Refer to chapter 7.1 *Saving autotest results* for more information regarding saving of autotest results.
- SAVE AS CUSTOM** Saves test setup as Custom autotest. Refer to chapter 6.2 *Custom autotest* for more information regarding Custom autotests.
- ESC** Returns to Code, Simple or Custom menu.

### Viewing autotest results

In the **View results** screen performed tests, results and their PASS / FAIL status are displayed. Furthermore the selected test results can be displayed with full details.

Options in View result screen:

▲ / ▼	Selects result of measurement.
TEST	Enters selected result of measurement (to be displayed in full details).
ESC	Returns to previous result screen.

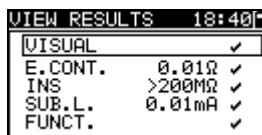


Figure 6.49: Overall result screen



Figure 6.50: Detailed result screen

### Saving autotest as Custom autotest

In the **Save as custom** screen last autotest can be stored as CUSTOM AUTOTEST.

Options in Save as custom screen:

▼ / ▲, TEST	Edit autotest name.
MEM (SAVE)	Saves autotest name.
ESC (DEL)	Deletes last character of autotest name.
ESC (CANCEL)	Returns to the previous menu.

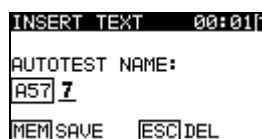


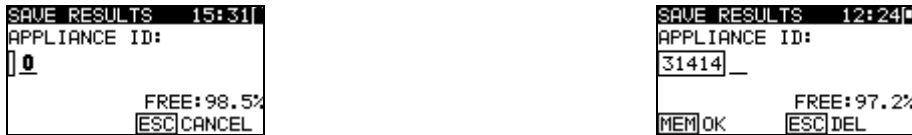
Figure 6.51: Save as custom screen

## 7 Working with autotest results

### 7.1 Saving autotest results

After selecting **Save results** in **Autotest results** menu, the autotest results will be stored in the internal memory of the instrument.

The appliance ID number and NAME can be added to the test results before the results are saved:



**Figure 7.1:** Save results menu (Appliance ID)

Keys:

<b>▼ / ▲, TEST</b>	Edit Appliance ID data.
<b>MEM (OK)</b>	Saves Appliance ID.
<b>ESC (DEL)</b>	Deletes last character of Appliance ID.
<b>ESC (CANCEL)</b>	Returns to the previous menu.

An Appliance ID of up to 14 alphanumeric characters can be entered. The Appliance ID can also be scanned with a barcode scanner or RFID reader/writer.

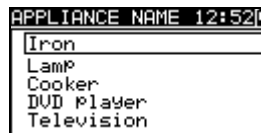


**Figure 7.2:** Save results menu (Appliance NAME)

Keys:

<b>▼ / ▲, TEST</b>	Edit Appliance NAME data.
<b>TAB (LIST)</b>	Offers last forty entered names.
<b>ESC (DEL)</b>	Deletes last character of Appliance NAME.
<b>ESC (CANCEL)</b>	Returns to the previous menu.
<b>MEM (SAVE)</b>	Saves Appliance NAME and returns to Autotest result menu.

An Appliance NAME of up to 14 alphanumeric characters can be entered. The Appliance NAME can also be scanned with a barcode scanner.



**Figure 7.3:** List menu (Appliance NAME)

#### Note

- › The instrument remembers last 40 entered appliances names.

## 7.2 Recalling results

Saved autotest results can be recalled, printed or deleted from the **Memory** menu. Enter the **Memory** menu from the **Setup** menu.

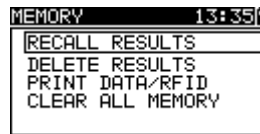


Figure 7.4: Memory menu

To enter the Recall results menu select **Recall results** in **Memory** menu. A list of Appliance ID's and NAMES are displayed in a chronological order (last performed measurement is displayed at the bottom of the list).

In the lower display the following data is displayed:

- Appliance ID, NAME;
- Date and time of the selected test;
- The overall ✓ / ✗ status of the selected test.

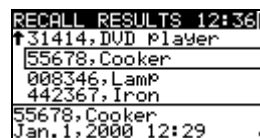


Figure 7.5: Recall results menu

Keys:

▲/▼, TEST	Enters View results menu for viewing autotest results.
ESC	Returns to Memory menu.

### Note

- MEM key can be used as shortcut to enter **Recall results** menu.

In the **View results** screen performed tests, results and their PASS / FAIL status are displayed. Furthermore the selected test results can be displayed with full details.

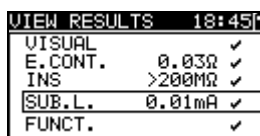


Figure 7.6: Overall result screen



Figure 7.7: Detailed result screen

Options in View result screen:

▲/▼	Selects result of measurement.
TEST	Enters selected result of measurement (to be displayed in full details).
ESC	Returns to previous result screen.

## 7.3 Deleting individual autotest results

To enter the Delete results menu select **Delete results** in **Memory** menu. A list of Appliance ID's and NAMES are displayed in a chronological order (last performed measurement will be displayed at the bottom of the list).

In the lower window of the display the following data is displayed:

- › Appliance ID, NAME;
- › date and time of the selected test;
- › the overall ✓ / ✗ status of the selected test.



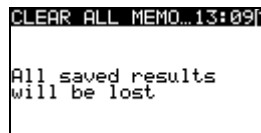
**Figure 7.8:** Delete results menu

Keys:

▲ / ▼	Select autotest result to be deleted.
<b>TEST</b>	Deletes selected autotest result.
<b>ESC</b>	Returns to <i>Setup menu</i> .

## 7.4 Clearing complete memory content

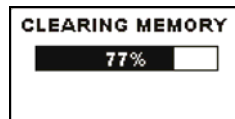
Select **CLEAR ALL MEMORY** in **Memory** menu. A warning will be displayed.



**Figure 7.9:** Clear all memory menu

Keys:

<b>TEST</b>	Confirms clearing of complete memory content.
<b>ESC</b>	Exits back to Memory menu without changes.



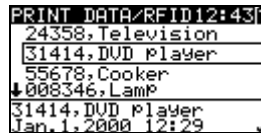
**Figure 7.10:** Clearing memory in progress

## 7.5 Printing and RFID tagging of individual autotest results

To print labels or results and write RFID tags select **Print data / RFID** in **Memory** menu. A list of Appliance ID's and NAMES are displayed in a chronological order (last performed measurement will be displayed at the bottom of the list).

In the lower window of the display the following data is displayed:

- › Appliance ID, NAME;
- › date and time of the selected test;
- › the overall ✓ / ✗ status of the selected test.

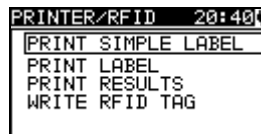


**Figure 7.11: Print data / RFID menu**

Keys:

▲ / ▼	Selects saved individual result.
TEST	Confirms selected result and enters <b>Printer / RFID</b> menu.
ESC	Exits back to Memory menu without changes.

In the **Printer / RFID** menu four options can be selected: Print simple label, Print label Print results and Write RFID tag.



**Figure 7.42: Printer / RFID menu**

Keys:

▲ / ▼	Selects action.
TEST	Confirms and executes selected action.
ESC	Exits back to Print data / RFID menu without changes.

### Print Simple label

Printed label includes: Appliance ID, Name, Test date Initials and Overall result (Pass or Fail).

### Print label

Printed label includes: Appliance ID, Barcode, Test date and Overall result (Pass or Fail).

### Print results

All the data stored at the specified location will be printed. That includes Appliance ID, Appliance NAME, Test date and time, Overall and individual measurement result (Pass or Fail), individual measurement values, limits and other settings.

### Write RFID tag

The test information is copied to RFID reader/writer. Pressing a **R/W** key on the RFID reader/writer writes Appliance ID, Test Date, Time and autotest code to RFID tag (for detailed information see RFID reader/writer instruction manual).

## 8 Communication

The instrument can communicate with the PATLink PRO PC software. The following actions are supported:

- › Saved results can be downloaded and stored to a PC.
- › Custom Auto sequences can be uploaded to the instrument.

There are two communication interfaces available on the instrument: USB or RS232. See chapter 4.8.9 *Communication port* for more information.

How to transfer stored data:

- |  |
|--|
| <ul style="list-style-type: none"><li>› RS232 communication: connect a PC COM port to the instrument PS/2 connector using the PS/2 - RS232 serial communication cable.</li><li>› USB communication: connect a PC USB port to the instrument USB connector using the USB interface cable.</li><li>› Switch on the PC and the instrument.</li><li>› Run the PATLink PRO program.</li><li>› Set communication port and baud rate speed.</li><li>› The instrument is prepared to upload / download data to the PC.</li></ul> |
|--|

**Note:**

- › USB drivers should be installed on PC before using the USB interface. Refer to USB installation instructions available on installation CD.

## 9 Maintenance

### 9.1 Periodic calibration


It is essential that all measuring instruments are regularly calibrated in order for the technical specification listed in this manual to be guaranteed. We recommend an annual calibration. The calibration has to be done by an authorized technical person only.

### 9.1 Replacing the fuses

The DeltaGT MI 3309 instrument contains two accessible fuses:

- F1, F2 fuse type:  
T 16 A / 250 V, 20×5 mm, breaking capacity 1500 A  
General input protection fuses.

#### Warnings:

-  Disconnect all measuring accessories, mains supply and power off the instrument before opening the battery or fuse compartment cover, hazardous voltage inside!
- Replace blown fuse with same type only, otherwise the instrument may be damaged and / or operator's safety impaired!

Position of fuses F1, F2 can be seen in **Figure 2.2** in chapter 2.2 *Connector panel*.

### 9.2 Service

For repairs under or out of warranty please contact your distributor for further information. Unauthorized person is not allowed to open the DeltaGT instrument. There are no user replaceable parts inside the instrument.

### 9.3 Cleaning

Use a soft cloth, slightly moistened with soapy water or alcohol to clean the surface of the instrument. Leave the instrument to dry totally before using it.

#### Notes:

- Do not use liquids based on petrol or hydrocarbons!
- Do not spill cleaning liquid over the instrument!

## 10 Instrument set and accessories

### Standard set of the instrument

- › Instrument MI 3309 DeltaGT
- › Test probe, black
- › Crocodile clip, black
- › Test lead, 1.5 m, black
- › 2 x IEC cord, 1.5 m
- › NiMH batteries, type HR 6 (size AA),, 6 pcs
- › USB cable
- › RS232 - PS/2 cable
- › PC SW PATLink PRO
- › Instruction manual
- › Small soft carrying bag
- › Calibration certificate

### Optional accessories

See the attached sheet for a list of optional accessories that are available on request from yours distributor.

## Appendix A – Barcode formats

The instrument DeltaGT supports two barcode formats (single and double).

### Autotest code and appliance ID

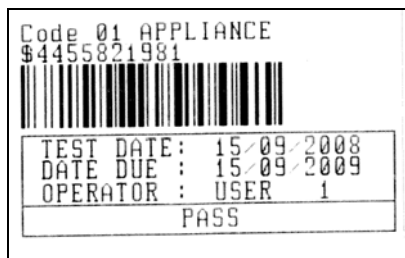
Autotest codes are represented as a three digits code. These autotest codes can also be represented by the barcode.

Using the barcode scanner, the instruments can accept autotest code from barcode label.

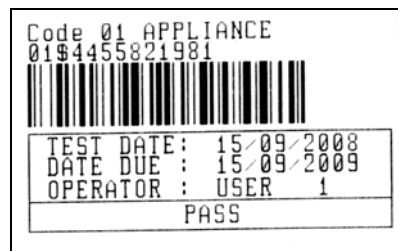


*Autotest code*

Also appliance ID can be read from barcode label.



*barcode system: single*



*barcode system: double*

*Examples of appliance labels*

A01	Autotest code
\$	Separator
4455821981	Appliance ID

### Note:

- › Special character »\$« between autotest code and appliance ID is used to distinguish code from appliance ID.

## Appendix B – Pre-programmed autotests (GER)

Pre-programmed autotest sequences table

Autotest shortcut code		A01	A02	A03	A04
		KI_1_Iso	KI_1_Iso_BLT	KI_1_Ia	KI_1_Ia_BLT
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	200 mA	200 mA	200 mA	200 mA
	Limit	0.30 $\Omega$	0.30 $\Omega$	0.30 $\Omega$	0.30 $\Omega$
	Time	5 s	5 s	5 s	5 s
<b>Insulation</b>	Output	500 V	500 V	<input type="checkbox"/>	<input type="checkbox"/>
	Limit	1.00 M $\Omega$	1.00 M $\Omega$	<input type="checkbox"/>	<input type="checkbox"/>
	Time	5 s	5 s	<input type="checkbox"/>	<input type="checkbox"/>
<b>Insulation (probe)</b>	Output	<input type="checkbox"/>	500 V	<input type="checkbox"/>	<input type="checkbox"/>
	Limit	<input type="checkbox"/>	2.00 M $\Omega$	<input type="checkbox"/>	<input type="checkbox"/>
	Time	<input type="checkbox"/>	5 s	<input type="checkbox"/>	<input type="checkbox"/>
<b>Sub. leakage</b>	Output	40 V	40 V	<input type="checkbox"/>	<input type="checkbox"/>
	Limit	3.50 mA	3.50 mA	<input type="checkbox"/>	<input type="checkbox"/>
	Time	5 s	5 s	<input type="checkbox"/>	<input type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	<input type="checkbox"/>	40 V	<input type="checkbox"/>	<input type="checkbox"/>
	Limit	<input type="checkbox"/>	0.50 mA	<input type="checkbox"/>	<input type="checkbox"/>
	Time	<input type="checkbox"/>	5 s	<input type="checkbox"/>	<input type="checkbox"/>
<b>Differential leakage</b>	Output	<input type="checkbox"/>	<input type="checkbox"/>	230 V	230 V
	Limit	<input type="checkbox"/>	<input type="checkbox"/>	3.50 mA	3.50 mA
	Time	<input type="checkbox"/>	<input type="checkbox"/>	180 s	180 s
<b>Touch leakage</b>	Output	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	230 V
	Limit	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	0.50 mA
	Time	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	180 s
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	230 V	230 V	230 V	230 V
	Limit	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
	Time	180 s	180 s	180 s	180 s
<b>TRMS clamp current</b>	Output	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
	Limit	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
	Time	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
<b>Polarity test</b>		<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>

\* optional

Pre-programmed autotest sequences table (cont'd)

Autotest shortcut code		A05	A06	A07	A08
		KI_2_Iso	KI_2_Ibs	KI_1_Isola	KI_1_IsolaBLT
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	200 mA	200 mA
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	0.30 $\Omega$	0.30 $\Omega$
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	5 s	5 s
<b>Insulation</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	500 V	500 V
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	1.00 M $\Omega$	1.00 M $\Omega$
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	5 s	5 s
<b>Insulation (probe)</b>	Output	500 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	500 V
	Limit	2.00 M $\Omega$	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	2.00 M $\Omega$
	Time	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	5 s
<b>Sub. leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	40 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	0.50 mA	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Differential leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	230 V	230 V
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	3.50 mA	3.50 mA
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	180 s	180 s
<b>Touch leakage</b>	Output	<input checked="" type="checkbox"/>	230 V	<input checked="" type="checkbox"/>	230 V
	Limit	<input checked="" type="checkbox"/>	0.50 mA	<input checked="" type="checkbox"/>	0.50 mA
	Time	<input checked="" type="checkbox"/>	180 s	<input checked="" type="checkbox"/>	180 s
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	230 V	230 V	230 V	230 V
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	180 s	180 s	180 s	180 s
<b>TRMS clamp current</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Polarity test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>


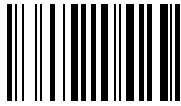




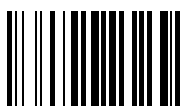


\* optional

Pre-programmed autotest sequences table (cont'd)




Autotest shortcut code		A09	A10	A11	A12
		KI_2_Isolbs	KI_2	KI_3_Iso	KI_3
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Insulation</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Insulation (probe)</b>	Output	500 V	<input checked="" type="checkbox"/>	500 V	<input checked="" type="checkbox"/>
	Limit	2.00 MΩ	<input checked="" type="checkbox"/>	0.250 MΩ	<input checked="" type="checkbox"/>
	Time	5 s	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>
<b>Sub. leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Differential leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Touch leakage</b>	Output	230 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	0.50 mA	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	180 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	230 V	230 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	180 s	180 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>TRMS clamp current</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Polarity test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>

\* optional

## METREL GmbH VDE tester test type card

Code	Autotest sequence name and descriptions		Limits	Barcode
A01	KI_1_Iso	Testing according to VDE. Class 1 device. Insulation resistance and substitute leakage current measurements are applicable.	Earth bond: 0.30 $\Omega$ Insulation: 1.00 M $\Omega$ Sub leakage: 3.50 mA	 A01
A02	KI_1_Iso_BLT	Testing according to VDE. Class 1 device with isolated accessible inductive parts. Insulation resistance and substitute leakage current measurements are applicable.	Earth bond: 0.30 $\Omega$ Insulation: 1.00 M $\Omega$ Insulation - P: 2.00 M $\Omega$ Sub leakage: 3.50 mA Sub leakage - P: 0.50 mA	 A02
A03	KI_1_Ia	Testing according to VDE. Class 1 device. Prüfung für Differenzstrom wird eingestellt.	Earth bond: 0.30 $\Omega$ Leakage: 3.50 mA	 A03
A04	KI_1_Ia_BLT	Testing according to VDE. Class 1 device with isolated accessible conductive parts. Prüfungen für Differenz- und Berührungsstrom werden eingestellt.	Earth bond: 0.30 $\Omega$ Leakage: 3.50 mA Touch leakage: 0.50 mA	 A04
A05	KI_2_Iso	Testing according to VDE. Class 2 device with isolated accessible conductive parts. Insulation resistance and substitute leakage current measurements are applicable.	Insulation - P: 2.00 M $\Omega$ Sub leakage - P: 0.50 mA	 A05
A06	KI_2_Ibs	Testing according to VDE. Class 2 device. Prüfung für Berührungsstrom wird eingestellt.	Touch leakage: 0.50 mA	 A06
A07	KI_1_Isola	Testing according to VDE. Class 1 device. Prüfungen für Isolation und Differenzstrom werden eingestellt.	Earth bond: 0.30 $\Omega$ Insulation: 1.00 M $\Omega$ Leakage: 3.50 mA	 A07
A08	KI_1_IsolaBLT	Testing according to VDE. Class 1 device with isolated accessible conductive parts. Prüfungen für Isolation, Differenz- und Berührungsstrom werden eingestellt.	Earth bond: 0.30 $\Omega$ Insulation: 1.00 M $\Omega$ Insulation - P: 2.00 M $\Omega$ Leakage: 3.50 mA Touch leakage: 0.50 mA	 A08
A09	KI_2_Isolbs	Testing according to VDE. Class 2 device with isolated accessible conductive parts. Prüfungen für Isolation und Berührungsstrom werden eingestellt.	Insulation - P: 2.00 M $\Omega$ Touch leakage: 0.50 mA	 A09

**METREL GmbH VDE tester test type card (cont'd)**

A10	KI_2	Testing according to VDE. Class 2 device without any isolated accessible conductive parts.		 A10
A11	KI_3_Iso	Testing according to VDE. Class 3 device with isolated accessible conductive parts.	Insulation - P: 0.25 MΩ	 A11
A12	KI_3	Testing according to VDE. Class 3 device without any isolated accessible conductive parts.		 A12

## Appendix C – Simple test codes (GER)

Simple test codes		CLASS I	CLASS II	CLASS III
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	200 mA	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	0.30 $\Omega$	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Insulation</b>	Output	500 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	1.00 M $\Omega$	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	2 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Insulation (probe)</b>	Output	<input checked="" type="checkbox"/>	500 V	500 V
	Limit	<input checked="" type="checkbox"/>	2.00 M $\Omega$	0.25 M $\Omega$
	Time	<input checked="" type="checkbox"/>	2 s	5 s
<b>Sub. leakage</b>	Output	40 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	3.50 mA	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	2 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	<input checked="" type="checkbox"/>	40 V	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	0.50 mA	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>
<b>Differential leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Touch leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>TRMS clamp current</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Polarity test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>

\* optional

## Appendix D – Pre-programmed autotests (NL)

Pre-programmed autotest sequences table

Autotest shortcut code		01	02	03	04
		KL_1_ALG	KL_2_ALG	KL_1_HEATERS	KL_1_PC
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	200 mA	<input checked="" type="checkbox"/>	200 mA	200 mA
	Limit	0.30 $\Omega$	<input checked="" type="checkbox"/>	0.30 $\Omega$	0.30 $\Omega$
	Time	5 s	<input checked="" type="checkbox"/>	5 s	5 s
<b>Insulation</b>	Output	500 V	<input checked="" type="checkbox"/>	500 V	<input checked="" type="checkbox"/>
	Limit	1.00 M $\Omega$	<input checked="" type="checkbox"/>	0.50 M $\Omega$	<input checked="" type="checkbox"/>
	Time	5 s	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>
<b>Insulation (probe)</b>	Output	<input checked="" type="checkbox"/>	500 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	2.00 M $\Omega$	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	40 V	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	7 mA	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Differential leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	230 V
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	0.50 mA
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	120 s
<b>Touch leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	230 V	230 V	230 V	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	10 s	10 s	10 s	<input checked="" type="checkbox"/>
<b>TRMS clamp current</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Polarity test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>

\* optional

Pre-programmed autotest sequences table (cont'd)

Autotest shortcut code		05	06	07	08
		KL_3_ALG	KL_1_AGMD	KABEL_5M_2.5MM	KABEL_15M_2.5MM
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	<input checked="" type="checkbox"/>	200 mA	200 mA	200 mA
	Limit	<input checked="" type="checkbox"/>	0.30 $\Omega$	0.30 $\Omega$	0.50 $\Omega$
	Time	<input checked="" type="checkbox"/>	5 s	5 s	5 s
<b>Insulation</b>	Output	<input checked="" type="checkbox"/>	500 V	500 V	500 V
	Limit	<input checked="" type="checkbox"/>	1.00 M $\Omega$	1.00 M $\Omega$	1.00 M $\Omega$
	Time	<input checked="" type="checkbox"/>	5 s	5 s	5 s
<b>Insulation (probe)</b>	Output	500 V	500 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	0.50 M $\Omega$	2.00 M $\Omega$	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	5 s	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Differential leakage</b>	Output	<input checked="" type="checkbox"/>	230 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	1.00 mA	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Touch leakage</b>	Output	<input checked="" type="checkbox"/>	230 V	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	0.50 mA	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	5 s	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>TRMS clamp current</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Polarity test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>

\* optional

Pre-programmed autotest sequences table (cont'd)

Autotest shortcut code		09	10
		KABEL_25M_2.5MM	KABEL_50M_2.5MM
<b>Visual test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Earth continuity</b>	Output	200 mA	200 mA
	Limit	0.70 $\Omega$	1.00 $\Omega$
	Time	5 s	5 s
<b>Insulation</b>	Output	500 V	500 V
	Limit	1.00 M $\Omega$	1.00 M $\Omega$
	Time	5 s	5 s
<b>Insulation (probe)</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Sub. leakage (probe)</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Differential leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Touch leakage</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Functional test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Power*</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>TRMS clamp current</b>	Output	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Limit	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
	Time	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
<b>Polarity test</b>		<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>

\* optional